


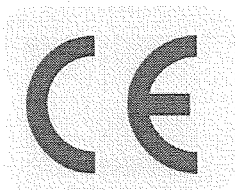
Test Verification of Conformity

On the basis of the referenced test report(s), the sample(s) of the below product has been found to comply with the relevant harmonized standard(s) to the directive(s) listed on this verification at the time the tests were carried out. The manufacturer may indicate compliance to only the said directives by signing a DoC himself and may affix the CE marking to products identical to the tested sample(s) if the product complies with all CE marking directives that has the product in their scope. In addition, the manufacturer shall file and keep the documentation according to the rules of the applicable directive(s) and shall consider changes of the standards as they may occur. Additional requirements, additional directives and local laws may be applicable.

Applicant Name & Address	: EAGLERISE ELECTRIC & ELECTRONIC (CHINA) CO., LTD. Guicheng Sci-Tech Industrial Park, Jianping Road, Nanhai District, Foshan City, Guangdong Province, P.R. China
Product(s) Tested	: Electronic controlgear for LED (Electronic LED driver)
Ratings and principal characteristics	: Input: 100-240 VAC; 50/60 Hz; 0,4 A; Class II; IP 20; SELV (Details refer to annex to Test Verification of Conformity)
Model(s)	: EIP030C****LX(Details refer to annex to Test Verification of Conformity)
Brand name	: 
Relevant Standard(s) / Specification(s) / Directive(s)	: EN 55015: 2006+A1: 2007+A2: 2009/ Limits and methods of measurement of radio disturbance characteristics of electrical lighting and similar equipment EN 61000-3-2: 2006+ A1: 2009+ A2: 2009/ Electromagnetic compatibility (EMC) – Part 3-2: Limits – Limits for harmonic current emissions (equipment input current ≤ 16 A per phase) EN 61000-3-3: 2008/ Electromagnetic compatibility (EMC) – Part 3-3: Limits – Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16 A per phase and not subject to conditional connection EN 61547: 2009/ Equipment for general lighting purposes — EMC immunity requirements EMC Directive 2004/108/EC
Verification Issuing Office Name & Address	: Same as Legal Entity
Verification/Report Number(s)	: 130222039GZU-001/ 130222039GZU-001: 2013-05-02

Note 1 : This verification is part of the full test report(s) and should be read in conjunction with it.

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Signature

Name: Jack Dai
 Position: Project Engineer
 Date: 02 May 2013

Annex to Test Verification of Conformity

This is an Annex to Test Verification of Conformity with Verification/Report Number(s): 130222039GZU-001/ 130422039GZU-001. The issuing office is Intertek Testing Services Shenzhen Ltd. Guangzhou Branch (Address: Block E, No, 7-2 Guang Dong Software Science Park, Caipin Road Guangzhou Science City, GETDD Guangzhou).

Ratings and principal characteristics

: Input: 100-240 VAC; 50/60 Hz; 0,4 A; Class II; IP 20; SELV;
ta 50 °C; tc 80 °C; Independent type; 110 °C thermal protection;
Inherently short-circuit proof; MM mark;
Output: Constant current type; 350 ~ 1200 mA; Max. 96 VDC;
Suitable for direct mounting on normally flammable surfaces;
Other parameters refer to appendix for model list.

Models

The 1st to 4th "*" indicate the output current of LED driver; can be replaced by "0350" to "1200" and increasing in multiplies of 50. "0350" means 350 mA; "1200" means 1200 mA.

Note 1: This annex is part of the Test Verification of Conformity and should be read in conjunction with it.

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Signature

Name: Jack Dai
Position: Project Engineer
Date: 02 May 2013

TEST REPORT

Applicant Name & Address : EAGLERISE ELECTRIC & ELECTRONIC (CHINA) CO., LTD.
Guicheng Sci-Tech Industrial Park, Jianping Road, Nanhai District, Foshan City, Guangdong Province, P.R. China

Manufacturing Site : Same as above

Sample Description

Product : Electronic controlgear for LED (Electronic LED driver)

Model No. : EIP030C****LX (Details refer to page 5)

Electrical Rating : Input: 100-240 VAC; 50/60 Hz; 0,4 A; Class II; IP 20; SELV(Details refer to page 5)

Date Received : 22 February 2013

Date Test Conducted : 22 February 2013-19 March 2013

Test standards : EN 55015: 2006+A1: 2007+A2: 2009
EN 61000-3-2: 2006+ A1:2009+ A2:2009
EN 61000-3-3: 2008
EN 61547: 2009

Test Result : Pass


Conclusion : The submitted samples complied with the above EMC standards.

Remark : None.

*****End of Page*****

Prepared and Checked By:

Approved By:



Sky Zhu
Engineer
Intertek Guangzhou



Jack Dai
Project Engineer
Intertek Guangzhou

02 May 2013 *Date*

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Intertek Testing Services Shenzhen Ltd. Guangzhou Branch
Block E, No.7-2 Guang Dong Software Science Park, Caipin Road, Guangzhou Science City, GETDD Guangzhou, China
Tel / Fax: 86-20-8213 9688/86-20-3205 7538

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1

TEST RESULTS SUMMARY

Test Item	Standard	Result
Continuous conducted disturbance voltage	EN 55015: 2006+A1: 2007+A2: 2009	Pass
Radiated electromagnetic disturbance (9 kHz -30 MHz)	EN 55015: 2006+A1: 2007+A2: 2009	Pass
Radiated Electromagnetic Disturbance (30 MHz -300 MHz)	EN 55015: 2006+A1: 2007+A2: 2009	Pass
Insertion loss	EN 55015: 2006+A1: 2007+A2: 2009	N/A
Harmonic of current	EN 61000-3-2: 2006+ A1:2009+ A2:2009	Pass
Flicker	EN 61000-3-3: 2008	Pass
ESD immunity	EN 61547:2009 Reference: EN 61000-4-2: 2009	Pass
Radiated EM field immunity	EN 61547:2009 Reference: EN 61000-4-3:2006+A1 :2008	Pass
EFT immunity	EN 61547:2009 Reference: EN 61000-4-4:2004	Pass
Surge immunity	EN 61547:2009 Reference: EN 61000-4-5:2006	Pass
Inject current immunity	EN 61547:2009 Reference: EN 61000-4-6:2009	Pass
Power frequency magnetic field immunity	EN 61547:2009 Reference: EN 61000-4-8:1993+A1:2001	N/A
Voltage dips and interruption immunity	EN 61547:2009 Reference: EN 61000-4-11:2004	Pass

Remark: 1. The symbol “N/A” in above table means Not Applicable.

2. When determining the test results, measurement uncertainty of tests has been considered.

2

EMC Results Conclusion (with Justification)

RE: EMC Testing Pursuant to EMC Directive 2004/108/EC Performed on the Electronic controlgear for LED, Models: EIP030C****LX.

We tested the Electronic controlgear for LED, Model: EIP030C0350LX, EIP030C0700LX, and EIP030C1200LX to determine if it was in compliance with the relevant EN standards as marked on the Test Results Summary. We found that the unit met the requirement of EN 55015, EN 61000-3-2, EN 61000-3-3, EN 61547 (EN 61000-4-2), EN 61547 (EN 61000-4-4), EN 61547 (EN 61000-4-6), EN 61547 (EN 61000-4-5), EN 61547 (EN 61000-4-11), & EN 61547 (EN 61000-4-3) standards when tested as received. The worst case's test data was presented in this test report.

All models had the same mechanical structure, output load, PCB layout; the only difference is the parameters for the components used in secondary circuit. EIP030C0350LX, EIP030C0700LX, and EIP030C1200LX were performed full test.

Product information:

EIP030C****LX

The 1st to 4th "*" indicate the output current of LED driver; can be replaced by "0350" to "1200" and increasing in multiplies of 50. "0350" means 350 mA; "1200" means 1200 mA.

Ratings:

Input: 100-240 VAC; 50/60 Hz; 0,4 A; Class II; IP 20; SELV;
ta 50 °C; tc 80 °C; Independent type; 110 °C thermal protection;
Inherently short-circuit proof; MM mark;
Output: Constant current type; 350 ~ 1200 mA; Max. 96 VDC;
Suitable for direct mounting on normally flammable surfaces;
Other parameters refer to appendix for model list.

The production units are required to conform to the initial sample as received when the units are placed on the market.

3 LABORATORY MEASUREMENTS

Configuration Information

Equipment Under Test (EUT):	Electronic controlgear for LED
Model:	EIP030C0350LX, EIP030C0700LX, EIP030C1200LX
Serial No.	Not Labeled
Support Equipment:	N/A
Rated Voltage:	100-240V 50/60Hz
Condition of Environment:	Temperature : 15~25°C Relative Humidity: 35~60% Atmosphere Pressure 86~106kPa

Notes:

1. The EMI measurements had been made in the operating mode produced the largest emission in the frequency band being investigated consistent with normal applications.

An attempt had been made to maximize the emission by varying the configuration of the EUT.

2. The EMS measurements had been made in the frequency bands being investigated, with the EUT in the most susceptible operating mode consistent with normal applications. The configuration of the test sample had been varied to achieve maximum susceptibility.

4 EMI TEST

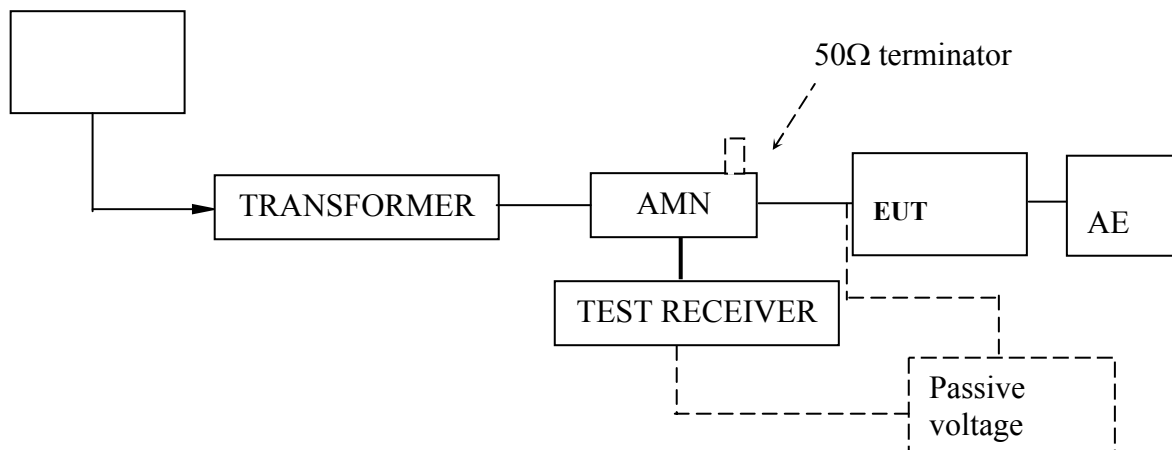
4.1 EN 55015 Continuous Conducted Disturbance Voltage Test

Test Result: Pass

4.1.1 Used Test Equipment

Equipment No.	Equipment	Model	Manufacturer
EM080-05	EMI receiver	ESCI	R&S
EM006-05	LISN	ENV216	R&S
EM004-04	EMC shield Room	8m×3m×3m	Zhongyu

4.1.2 Block Diagram of Test Setup



4.1.3 Test Setup and Procedure

The EUT was set to achieve the maximum emission level. The mains terminal disturbance voltage was measured with the EUT in a shielded room. The EUT was connected to AC power source through an Artificial Mains Network which provide a 50Ω linear impedance. Artificial hand is used if appropriate (for handheld apparatus). The load/control terminal disturbance voltage was measured with passive voltage probe if appropriate.

The EUT was placed on a 0.4m high non-metallic table above a metallic plane, and 0.4m from wall of shielded room which is considered as Ground Reference Plane (GRP) (For floor standing EUT, was placed on a 0.1m high non-metallic supported on GRP) The EUT keeps a distance of at least 0.8m from any other of the metallic surface. The Artificial Mains Network is situated at a distance of 0.8m from the EUT.

During the test, mains lead of EUT excess 0.8m was folded back and forth parallel to the lead so as to form a horizontal bundle with a length between 0.3m and 0.4m.

The bandwidth of test receiver was set at 200Hz in the frequency range from 9kHz to 150kHz, and 9kHz in the frequency range from 150kHz to 30MHz.



4.1.4 Test Data

At main terminal: Pass

Model: EIP030C0350LX

Tested Wire: Live

Operation Mode: EUT ON

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	CE1511QP			
Trace2:	CE1511AV			
Trace3:	---			
TRACE	FREQUENCY	LEVEL dB μ V		DELTA LIMIT dB
1 Quasi Peak	178 kHz	46.44 L1		-18.13
2 Average	178 kHz	33.42 L1		-21.15
1 Quasi Peak	202 kHz	43.27 L1		-20.25
1 Quasi Peak	354 kHz	37.56 L1		-21.30
1 Quasi Peak	522 kHz	35.57 L1		-20.42
1 Quasi Peak	2.334 MHz	35.98 L1		-20.01
2 Average	3.814 MHz	33.18 L1		-12.81
1 Quasi Peak	3.862 MHz	41.28 L1		-14.71
1 Quasi Peak	4.85 MHz	44.93 L1		-11.06
2 Average	4.87 MHz	35.76 L1		-10.23
2 Average	6.858 MHz	32.52 L1		-17.47
1 Quasi Peak	6.946 MHz	43.36 L1		-16.63
1 Quasi Peak	11.034 MHz	37.23 L1		-22.76

Tested Wire: Neutral

Operation Mode: EUT ON

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	CE1511QP			
Trace2:	CE1511AV			
Trace3:	---			
TRACE	FREQUENCY	LEVEL dB μ V		DELTA LIMIT dB
1 Quasi Peak	150 kHz	43.72 L1		-36.28
1 Quasi Peak	174 kHz	48.27 L1		-16.49
2 Average	174 kHz	33.36 L1		-21.40
1 Quasi Peak	3.774 MHz	38.97 L1		-17.02
1 Quasi Peak	4.17 MHz	42.75 L1		-13.24
1 Quasi Peak	5.958 MHz	42.78 L1		-17.21



Report No.: 130222039GZU-001
 Issued: 2013-05-02

Model: EIP030C0700LX

Tested Wire: Live

Operation Mode: EUT ON

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	CE1511QP			
Trace2:	CE1511AV			
Trace3:	---			
TRACE	FREQUENCY	LEVEL	dB μ V	DELTA LIMIT
1 Quasi Peak	166 kHz	50.67	L1	-14.48
2 Average	166 kHz	36.18	L1	-18.97
1 Quasi Peak	190 kHz	45.33	L1	-18.69
1 Quasi Peak	518 kHz	39.08	L1	-16.91
1 Quasi Peak	574 kHz	40.41	L1	-15.58
1 Quasi Peak	1.334 MHz	39.27	L1	-16.72
2 Average	2.266 MHz	28.25	L1	-17.74
1 Quasi Peak	2.35 MHz	41.75	L1	-14.24
1 Quasi Peak	3.734 MHz	41.10	L1	-14.90
2 Average	3.806 MHz	30.92	L1	-15.07
2 Average	4.446 MHz	29.97	L1	-16.03
1 Quasi Peak	4.718 MHz	40.43	L1	-15.56
1 Quasi Peak	10.326 MHz	35.77	L1	-24.22
2 Average	12.206 MHz	30.77	L1	-19.22
1 Quasi Peak	12.554 MHz	39.52	L1	-20.47

Tested Wire: Neutral

Operation Mode: EUT ON

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	CE1511QP			
Trace2:	CE1511AV			
Trace3:	---			
TRACE	FREQUENCY	LEVEL	dB μ V	DELTA LIMIT
1 Quasi Peak	166 kHz	55.05	L1	-10.10
2 Average	166 kHz	41.96	L1	-13.19
1 Quasi Peak	190 kHz	51.29	L1	-12.74
2 Average	246 kHz	34.61	L1	-17.27
2 Average	486 kHz	31.72	L1	-14.51
1 Quasi Peak	502 kHz	45.77	L1	-10.22
1 Quasi Peak	522 kHz	44.50	L1	-11.49
2 Average	570 kHz	28.82	L1	-17.17
2 Average	894 kHz	28.46	L1	-17.53
1 Quasi Peak	922 kHz	42.32	L1	-13.67
2 Average	1.862 MHz	29.22	L1	-16.77
1 Quasi Peak	2.35 MHz	43.05	L1	-12.94
1 Quasi Peak	3.73 MHz	42.62	L1	-13.37
2 Average	3.818 MHz	33.15	L1	-12.84
2 Average	4.206 MHz	33.36	L1	-12.63
2 Average	12.174 MHz	33.05	L1	-16.95
1 Quasi Peak	12.242 MHz	42.21	L1	-17.78



Report No.: 130222039GZU-001
Issued: 2013-05-02

Model: EIP030C1200LX

Tested Wire: Live

Operation Mode: EUT ON

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	CE1511QP			
Trace2:	CE1511AV			
Trace3:	---			
TRACE	FREQUENCY	LEVEL dB μ V		DELTA LIMIT dB
1 Quasi Peak	166 kHz	53.39 L1		-11.76
2 Average	166 kHz	40.76 L1		-14.39
1 Quasi Peak	190 kHz	49.47 L1		-14.55
1 Quasi Peak	570 kHz	38.73 L1		-17.26
1 Quasi Peak	1.334 MHz	39.32 L1		-16.67
1 Quasi Peak	1.638 MHz	41.55 L1		-14.44
1 Quasi Peak	3.586 MHz	37.13 L1		-18.86
1 Quasi Peak	4.19 MHz	36.54 L1		-19.45
1 Quasi Peak	13.646 MHz	39.31 L1		-20.68

Tested Wire: Neutral

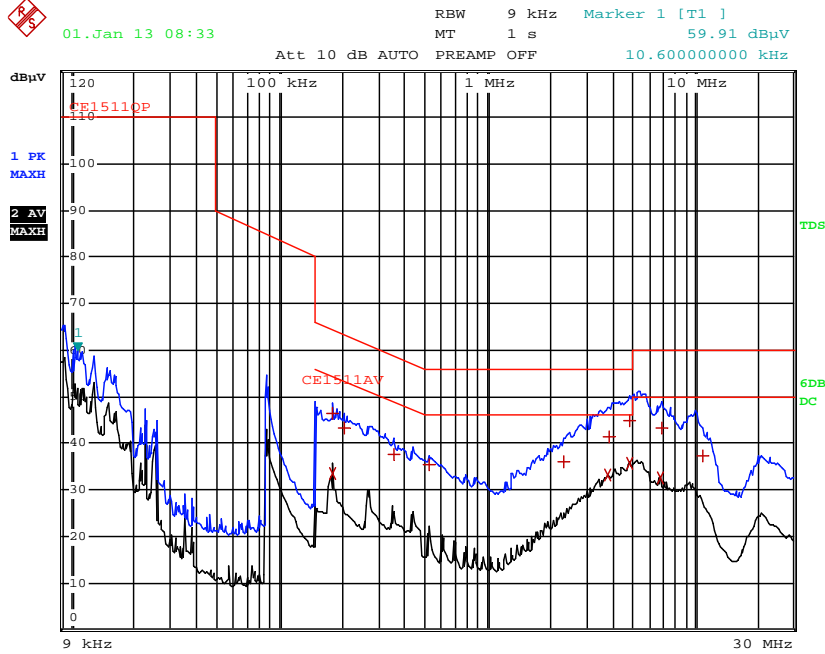
Operation Mode: EUT ON

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	CE1511QP			
Trace2:	CE1511AV			
Trace3:	---			
TRACE	FREQUENCY	LEVEL dB μ V		DELTA LIMIT dB
2 Average	166 kHz	36.36 L1		-18.78
1 Quasi Peak	182 kHz	47.14 L1		-17.25
1 Quasi Peak	206 kHz	45.51 L1		-17.85
2 Average	494 kHz	32.23 L1		-13.86
1 Quasi Peak	506 kHz	45.58 L1		-10.41
1 Quasi Peak	526 kHz	44.70 L1		-11.29
1 Quasi Peak	922 kHz	42.57 L1		-13.42
1 Quasi Peak	1.67 MHz	40.71 L1		-15.28
1 Quasi Peak	3.446 MHz	41.90 L1		-14.09
1 Quasi Peak	4.186 MHz	41.28 L1		-14.71
1 Quasi Peak	13.166 MHz	40.31 L1		-19.68

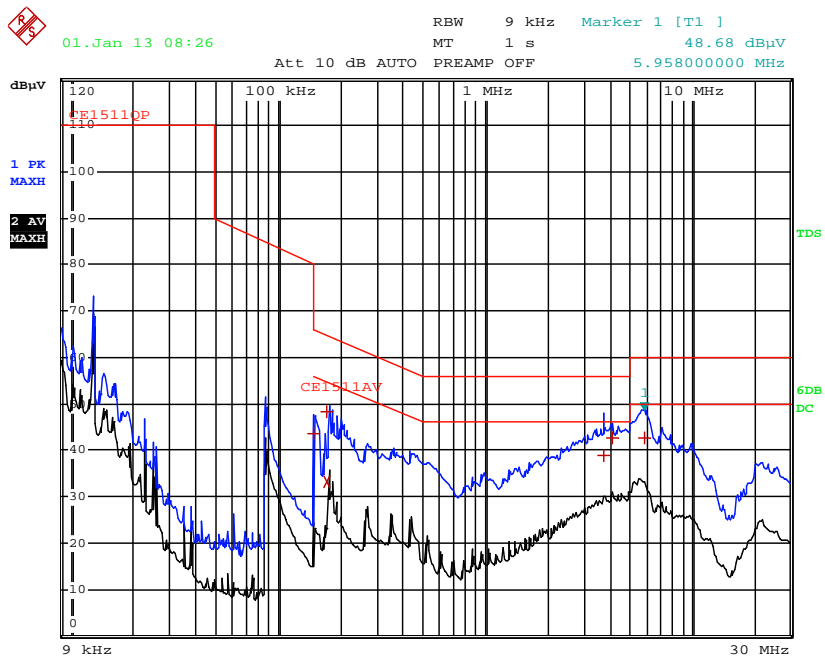
At load/control terminal: Not Applicable

4.1.5 Emission Curve

At mains terminal:
 Model: EIP030C0350LX
 Tested Wire: Live

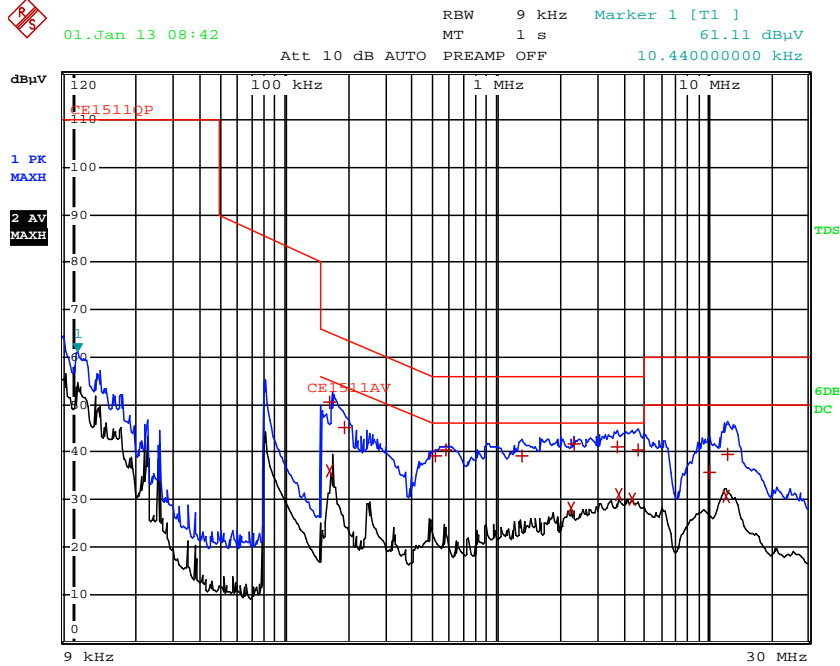


Tested Wire: Neutral

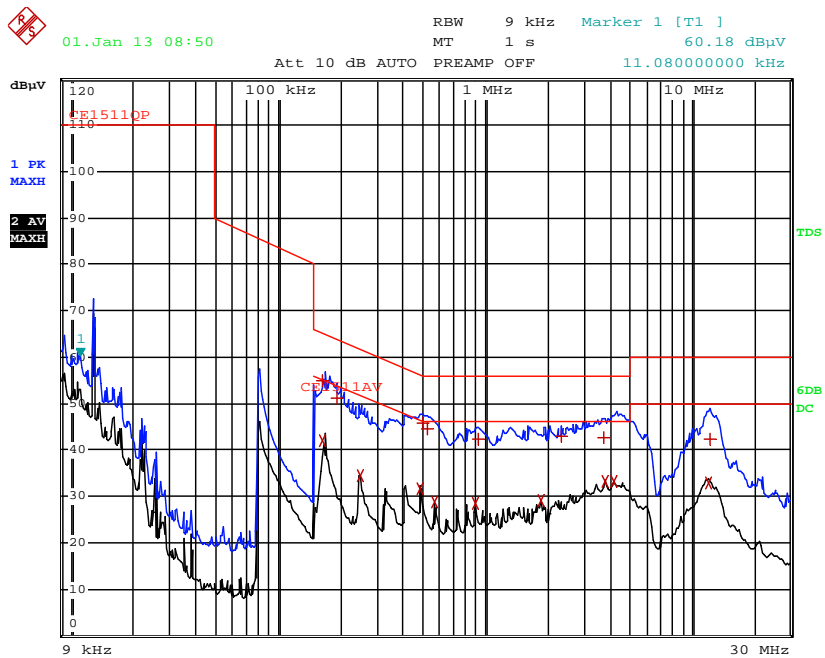




Model: EIP030C0700LX
Tested Wire: Live



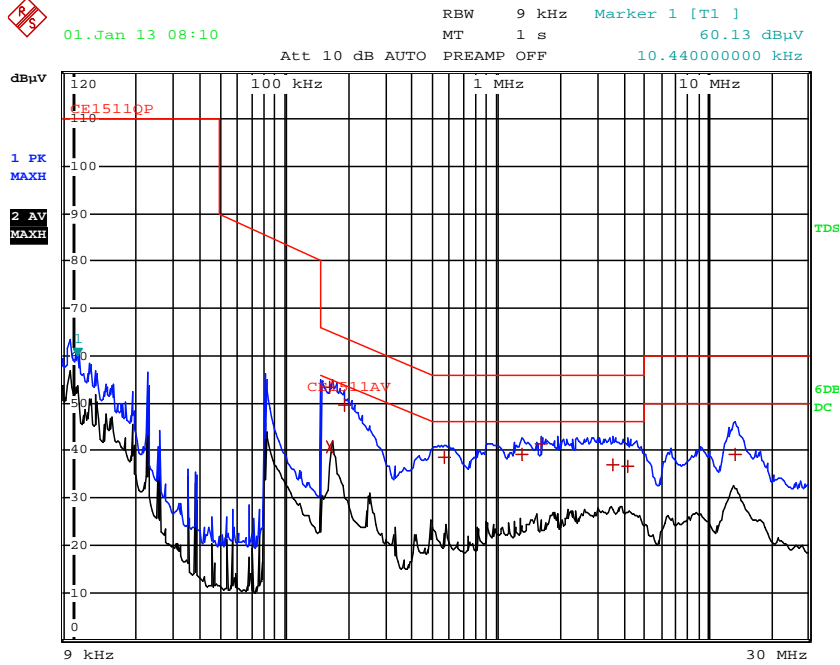
Tested Wire: Neutral



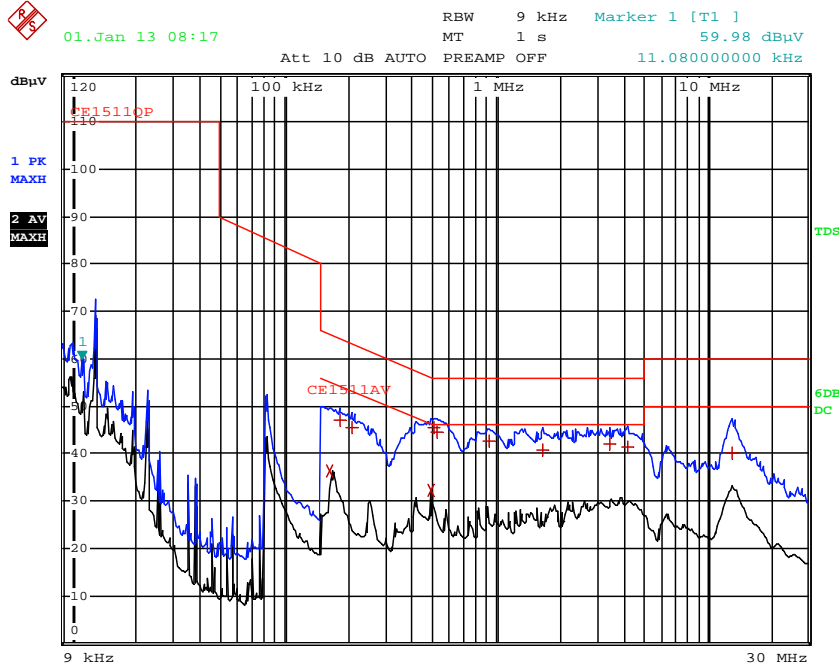


Model: EIP030C1200LX

Tested Wire: Live



Tested Wire: Neutral



At load/control terminal:

Not Applicable.

4.1.6 Measurement Uncertainty

The measurement uncertainty describes the overall uncertainty of the given measured value during the operation of the EUT.

Measurement uncertainty is calculated in accordance with CISPR 16-4-2: 2003.

Measurement uncertainty of mains terminal disturbance voltage in CISPR band A: 1.6 dB.

Measurement uncertainty of mains terminal disturbance voltage in CISPR band B: 2.3 dB.

The measurement uncertainty is given with a confidence of 95%, k=2.

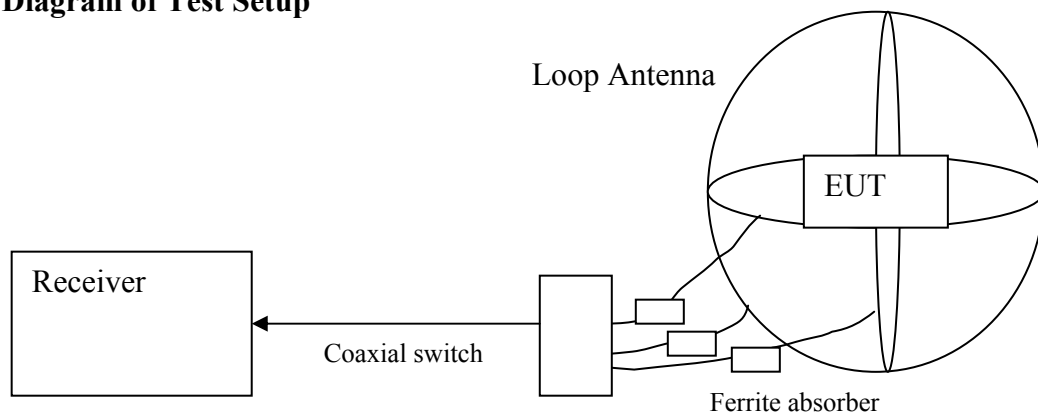
4.2 EN 55015 Radiated Electromagnetic Disturbance (9 kHz-30 MHz)

Test Result: Pass

4.2.1 Used Test Equipment

Equipment No.	Equipment	Model	Manufacturer
EM080-05	EMI receiver	ESCI	R&S
EM061-04	Triple Loop Antenna	HXYZ9170	SCHWARZBECK
EM004-03	EMC shield Room	8m×4m×3m	Zhongyu

4.2.2 Block Diagram of Test Setup



4.2.3 Test Setup and Procedure

The EUT is placed in the centre of the loop antenna system(LAS). The current induced by the magnetic field from the EUT into each of the three large loop antennas of the LAS is measured by connecting the current probe of the large loop antenna to a measuring receiver. During the measurements the EUT remains in a fixed position.

The currents in the three large loop antenna, origination from the three mutually orthogonal magnetic field components, are measured in sequence. Each current level measured shall comply with the emission limit, expressed in dBμA, as specified in table of EN 55015.

The distance between the outer perimeter of the LAS and nearby objects, such as floor and walls, shall be at least 0.5m.

To avoid unwanted capacitive coupling between the EUT and the LAS, the maximum dimensions of the EUT shall allow a distance of at least 0.2m between the EUT and the standardized 2m large loop antenna of the LAS.

The position of the mains lead shall be optimized for maximum current induction. In general, this position will not be critical when the EUT complies with the conducted emission limit.

4.2.4 Test Data

Model: EIP030C0350LX

Frequency [MHz]	X axis [dB(μA)]	Y axis [dB(μA)]	Z axis [dB(μA)]	Limit [dB(μA)]
0.009	<78	<78	<78	88.0
0.050	<78	<78	<78	88.0
0.100	<64	<64	<64	74.0
0.160	<47	<47	<47	57.2
0.240	<40	<40	<40	52.4
0.550	<30	<30	<30	42.5
1.000	<25	<25	<25	35.4
1.400	<20	<20	<20	31.4
2.000	<17	<17	<17	27.1
3.500	<12	<12	<12	22.0
6.000	<12	<12	<12	22.0
10.000	<12	<12	<12	22.0
22.000	<12	<12	<12	22.0
30.000	<12	<12	<12	22.0

Model: EIP030C0700LX

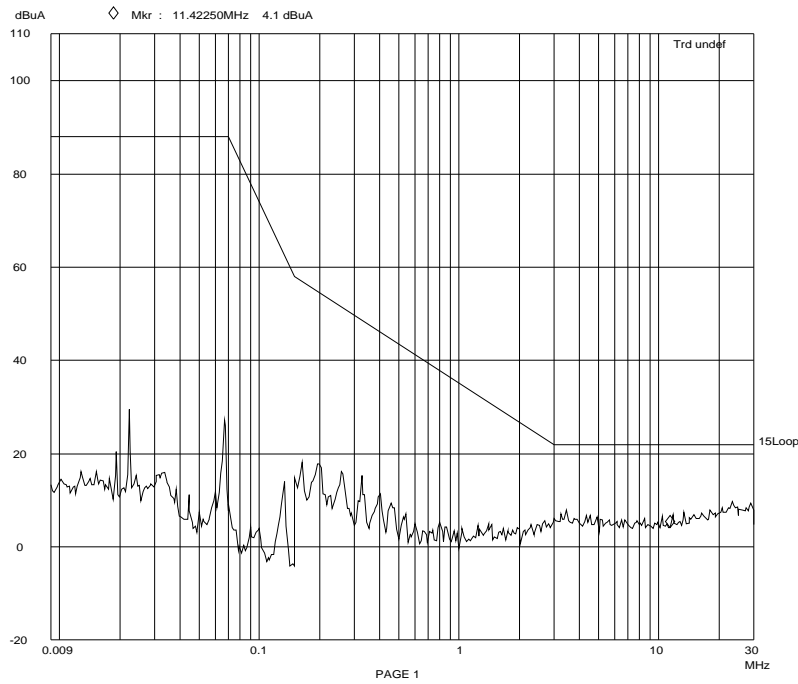
Frequency [MHz]	X axis [dB(μA)]	Y axis [dB(μA)]	Z axis [dB(μA)]	Limit [dB(μA)]
0.009	<78	<78	<78	88.0
0.050	<78	<78	<78	88.0
0.100	<64	<64	<64	74.0
0.160	<47	<47	<47	57.2
0.240	<40	<40	<40	52.4
0.550	<30	<30	<30	42.5
1.000	<25	<25	<25	35.4
1.400	<20	<20	<20	31.4
2.000	<17	<17	<17	27.1
3.500	<12	<12	<12	22.0
6.000	<12	<12	<12	22.0
10.000	<12	<12	<12	22.0
22.000	<12	<12	<12	22.0
30.000	<12	<12	<12	22.0

Model: EIP030C1200LX

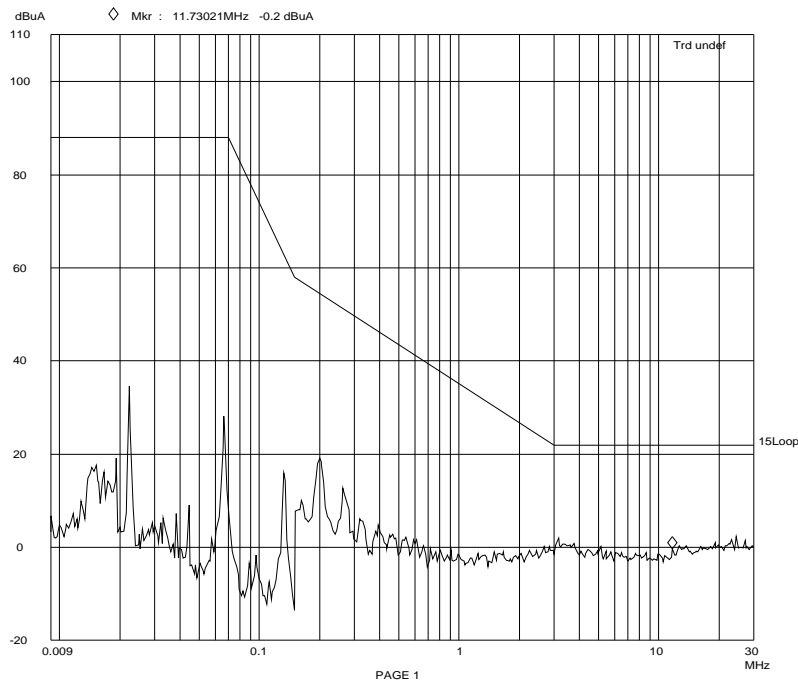
Frequency [MHz]	X axis [dB(μA)]	Y axis [dB(μA)]	Z axis [dB(μA)]	Limit [dB(μA)]
0.009	<78	<78	<78	88.0
0.050	<78	<78	<78	88.0
0.100	<64	<64	<64	74.0
0.160	<47	<47	<47	57.2
0.240	<40	<40	<40	52.4
0.550	<30	<30	<30	42.5
1.000	<25	<25	<25	35.4
1.400	<20	<20	<20	31.4
2.000	<17	<17	<17	27.1
3.500	<12	<12	<12	22.0
6.000	<12	<12	<12	22.0
10.000	<12	<12	<12	22.0
22.000	<12	<12	<12	22.0
30.000	<12	<12	<12	22.0

4.2.5 Test Curve Model: EIP030C0350LX

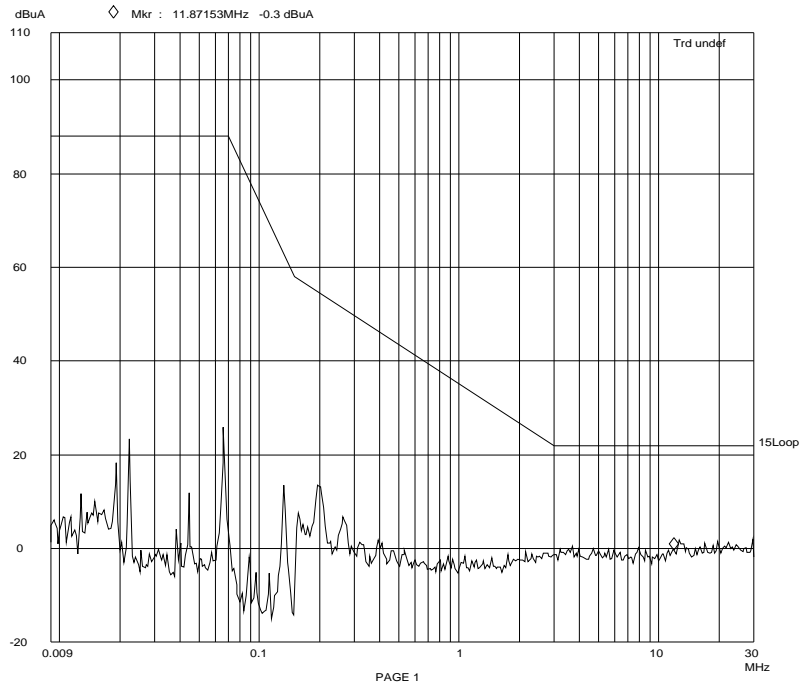
X axis



Y axis

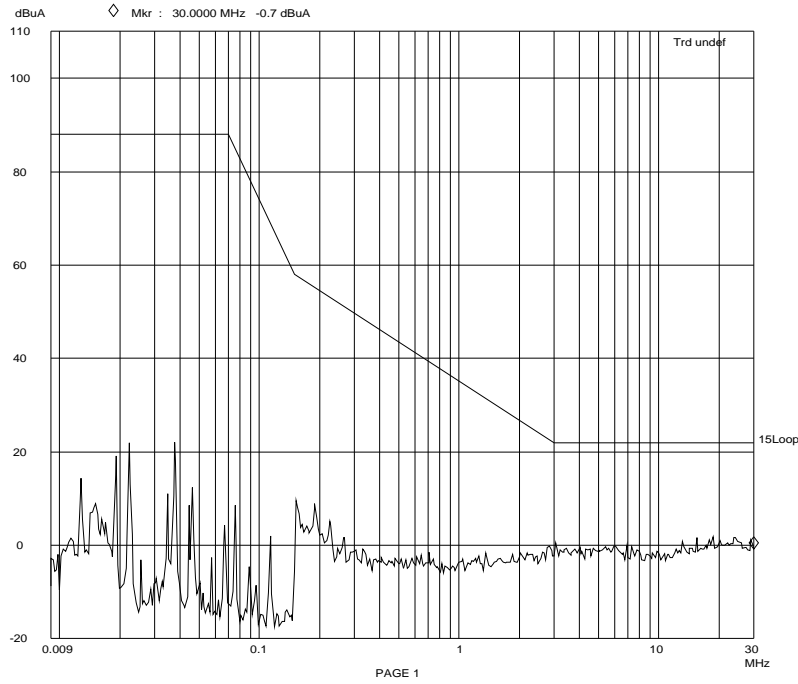


Z axis

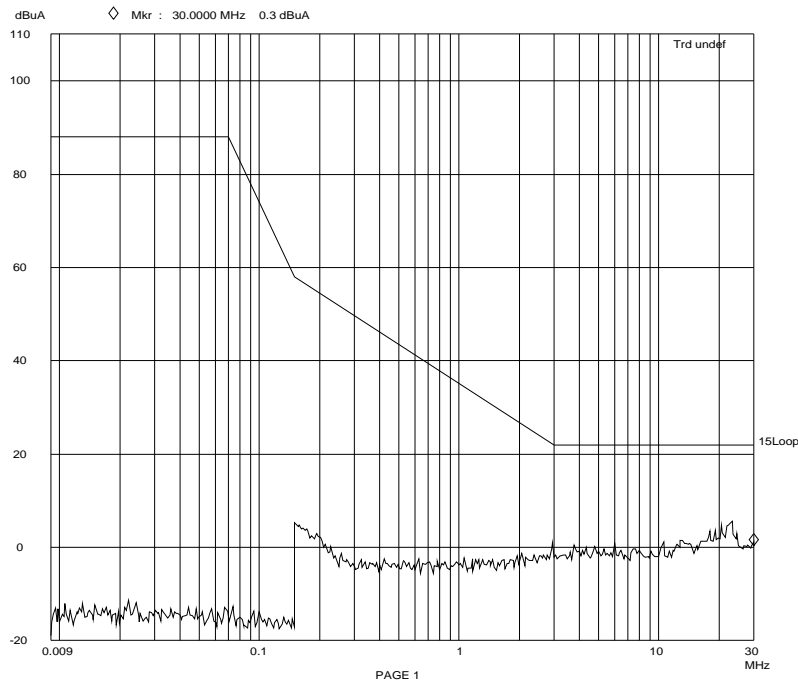


Model: EIP030C0700LX

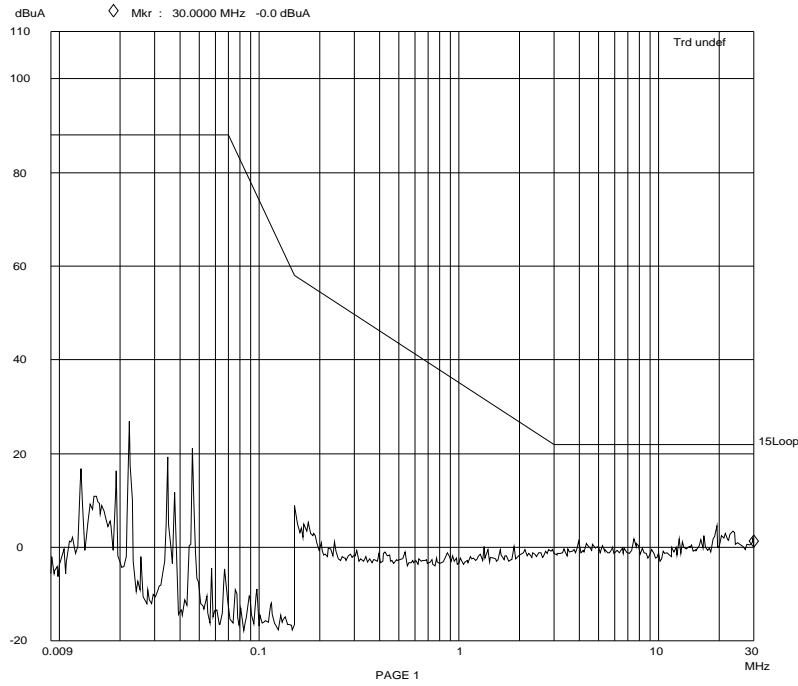
X axis



Y axis

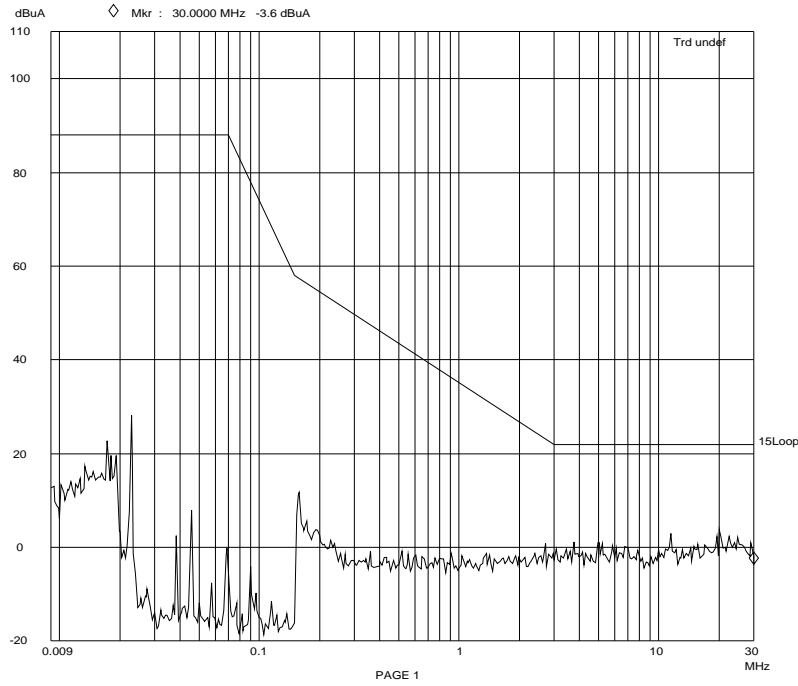


Z axis

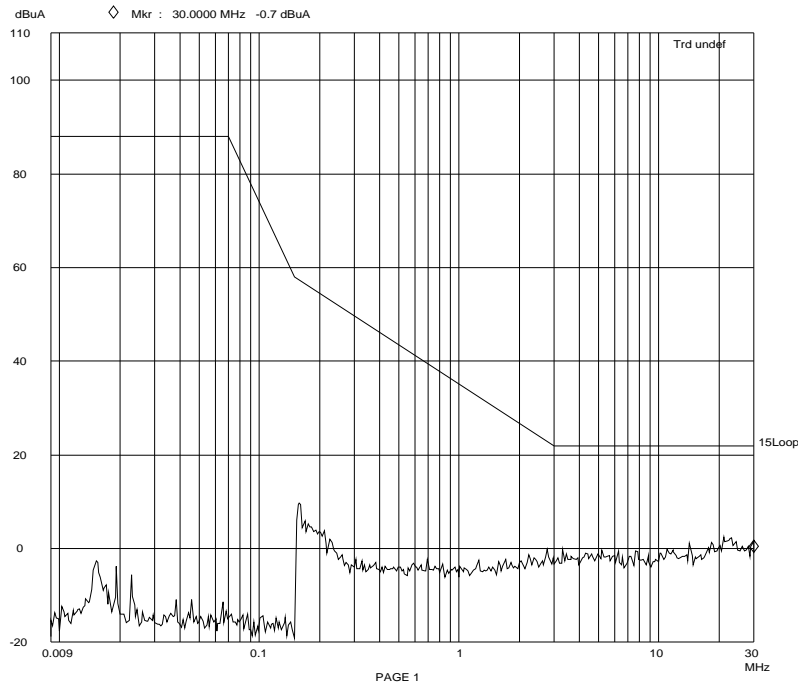


Model: EIP030C1200LX

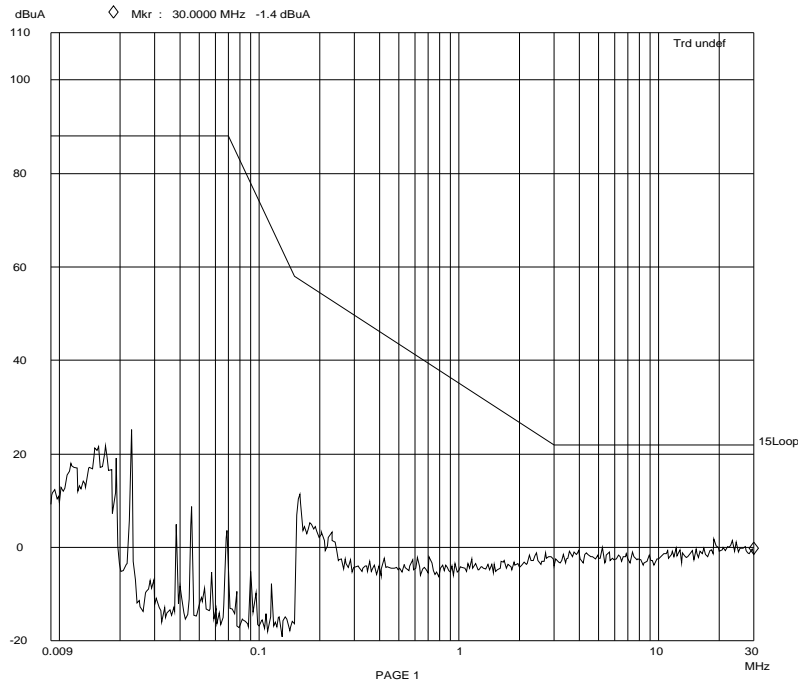
X axis



Y axis



Z axis



4.2.6 Measurement Uncertainty

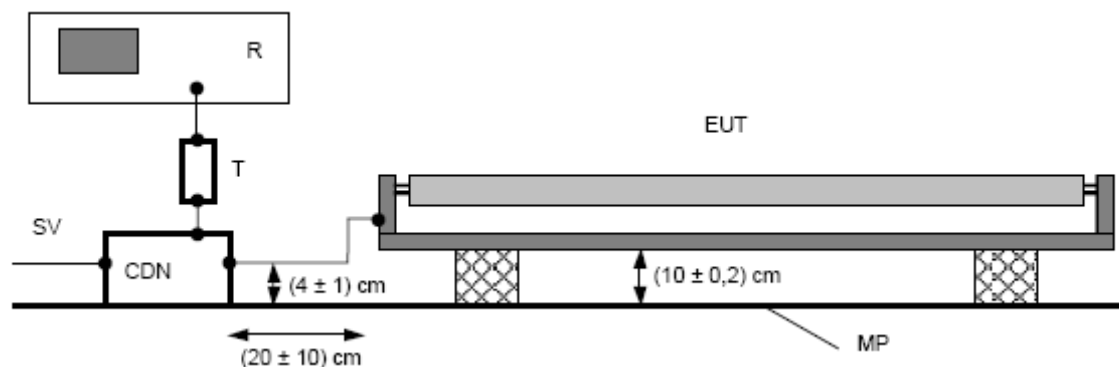
The measurement uncertainty for induction current is under consideration according to CISPR 16-4-2:2003.

**4.3 EN 55015 Radiated Electromagnetic Disturbance (30 MHz -300 MHz, CDN method)
 Test Result: Pass**

4.3.1 Used Test Equipment

Equip. No.	Equipment	Model	Manufacturer
EM004-04	EMC shield Room	8m×3m×3m	Zhongyu
EM080-05	EMI receiver	ESCI	R&S
EM003-02	Coupling & Decoupling Network	CDN M2 16	TESEQ
EM003-01-05	Attenuator	6dB	drhubert

4.3.2 Block Diagram of Test Setup



4.3.3 Test Setup and Procedure

The EUT shall be placed on a non-conducting table with a height of (10 ± 0.2) cm.
 The EUT is connected to CDN with a length of (20 ± 10) cm and the distance of the cable to the metal plate should be (4 ± 1) cm.
 The RF output of the CDN is connected to EMI receiver via a 6 dB, 50Ω attenuator.
 The distance from any conductive parts shall be more than 40 cm.

Prior to a measurement, the lamps shall be operated until stabilization has been reached.
 5min for incandescent lamps, 15min for fluorescent lamp, 30min for other discharge lamp.

The EUT should be powered on before the coaxial cable is connected to receiver every time.
 And the coaxial cable should be removed from receiver before stopping EUT.



4.3.4 Test Data

Model: EIP030C0350LX

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	15CDN			
Trace2:	---			
Trace3:	---			
TRACE	FREQUENCY	LEVEL dBµV		DELTA LIMIT dB
1 Quasi Peak	74.4 MHz	44.43 L1		-12.02
1 Quasi Peak	99.88 MHz	41.59 L1		-12.41
1 Quasi Peak	48.76 MHz	46.03 L1		-13.93
1 Quasi Peak	70.52 MHz	42.71 L1		-14.18
1 Quasi Peak	120.44 MHz	39.67 L1		-14.32
1 Quasi Peak	87.72 MHz	39.88 L1		-15.20
1 Quasi Peak	126.52 MHz	38.45 L1		-15.54
1 Quasi Peak	61.52 MHz	42.41 L1		-15.61
1 Quasi Peak	36.48 MHz	45.68 L1		-16.68
1 Quasi Peak	30.96 MHz	46.75 L1		-16.98
1 Quasi Peak	44.92 MHz	43.31 L1		-17.33
1 Quasi Peak	214.24 MHz	36.09 L1		-17.90
1 Quasi Peak	183.92 MHz	35.94 L1		-18.05
1 Quasi Peak	229.64 MHz	33.83 L1		-20.16
1 Quasi Peak	167.64 MHz	33.33 L1		-20.66

Model: EIP030C0700LX

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	15CDN			
Trace2:	---			
Trace3:	---			
TRACE	FREQUENCY	LEVEL dBµV		DELTA LIMIT dB
1 Quasi Peak	101.72 MHz	45.22 L1		-8.77
1 Quasi Peak	87.04 MHz	44.07 L1		-11.08
1 Quasi Peak	80.08 MHz	44.50 L1		-11.34
1 Quasi Peak	55.68 MHz	46.36 L1		-12.49
1 Quasi Peak	109.56 MHz	40.77 L1		-13.22
1 Quasi Peak	52.36 MHz	44.83 L1		-14.54
1 Quasi Peak	145.8 MHz	39.24 L1		-14.75
1 Quasi Peak	152.8 MHz	38.37 L1		-15.62
1 Quasi Peak	69.04 MHz	40.50 L1		-16.56
1 Quasi Peak	173.04 MHz	36.07 L1		-17.92
1 Quasi Peak	30.12 MHz	45.44 L1		-18.52
1 Quasi Peak	35.12 MHz	42.57 L1		-20.11
1 Quasi Peak	195.44 MHz	33.74 L1		-20.25
1 Quasi Peak	44.52 MHz	40.01 L1		-20.70
1 Quasi Peak	226.92 MHz	31.32 L1		-22.67
1 Quasi Peak	295.84 MHz	34.26 L1		-26.73



Report No.: 130222039GZU-001
Issued: 2013-05-02

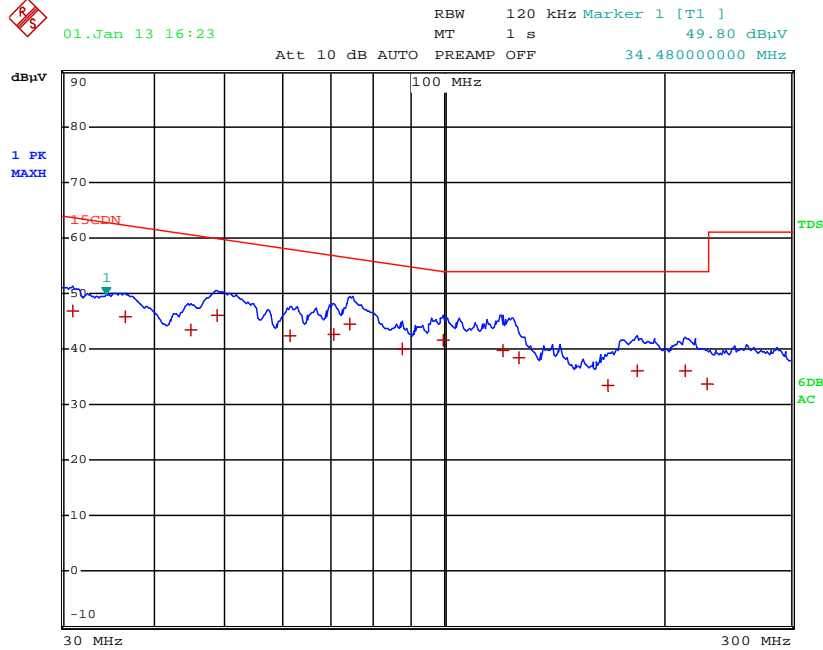
Model: EIP030C1200LX

EDIT PEAK LIST (Final Measurement Results)				
Trace1:	15CDN			
Trace2:	---			
Trace3:	---			
TRACE	FREQUENCY	LEVEL dBuV		DELTA LIMIT dB
1 Quasi Peak	89.12 MHz	45.47 L1		-9.48
1 Quasi Peak	101.68 MHz	39.86 L1		-14.13
1 Quasi Peak	42 MHz	46.29 L1		-14.91
1 Quasi Peak	55.72 MHz	43.78 L1		-15.06
1 Quasi Peak	40 MHz	46.34 L1		-15.26
1 Quasi Peak	109.6 MHz	38.29 L1		-15.70
1 Quasi Peak	147.48 MHz	37.91 L1		-16.08
1 Quasi Peak	30.32 MHz	47.68 L1		-16.22
1 Quasi Peak	79.04 MHz	39.41 L1		-16.53
1 Quasi Peak	209.28 MHz	37.44 L1		-16.55
1 Quasi Peak	142.04 MHz	37.26 L1		-16.73
1 Quasi Peak	53.2 MHz	42.46 L1		-16.77
1 Quasi Peak	65.2 MHz	40.16 L1		-17.39
1 Quasi Peak	186 MHz	35.77 L1		-18.22
1 Quasi Peak	226.24 MHz	33.60 L1		-20.39

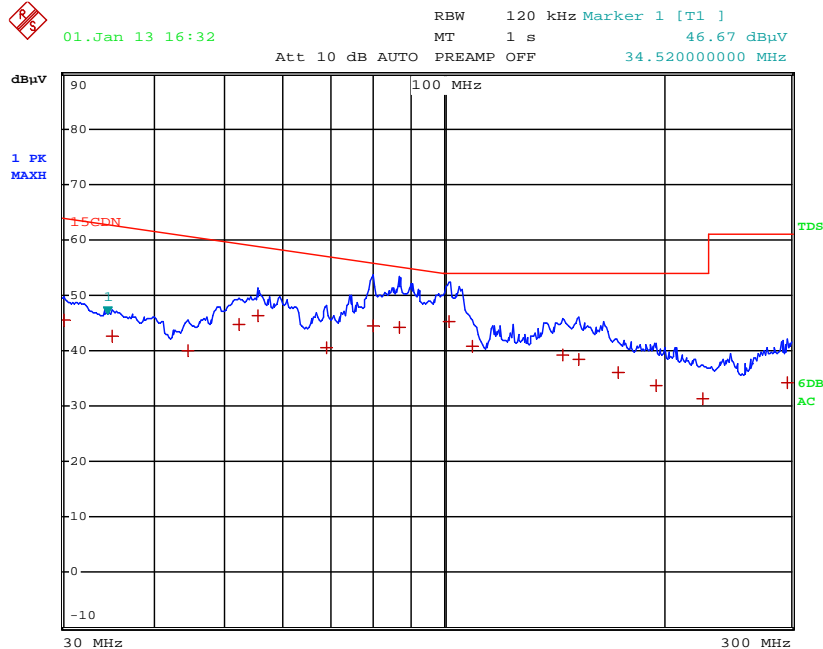


4.3.5 Test Curve

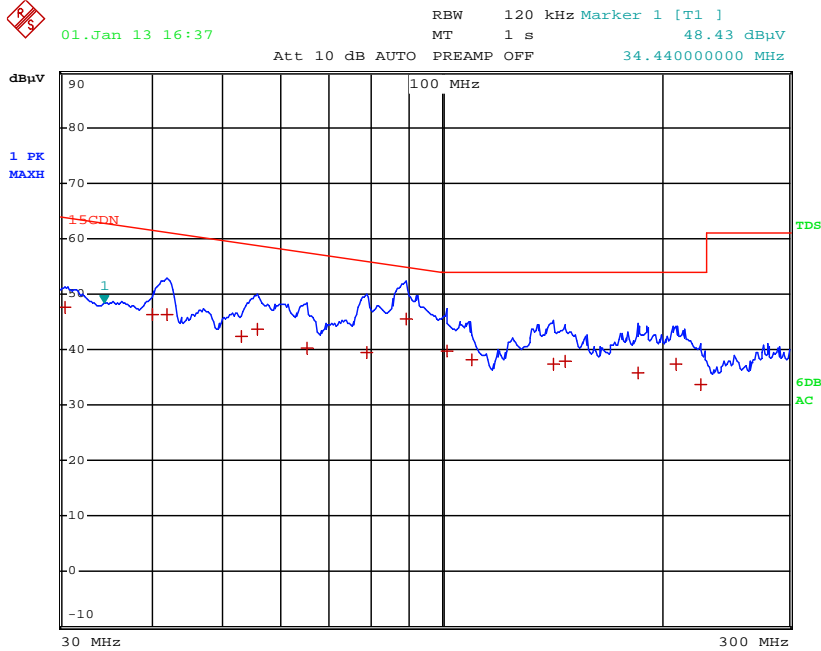
Model: EIP030C0350LX



Model: EIP030C0700LX



Model: EIP030C1200LX



4.3.6 Measurement uncertainty

The measurement uncertainty for Radiated Electromagnetic Disturbance t (30 MHz -300 MHz, CDN method) is under consideration according to CISPR 16-4-2:2003.

4.4 Insertion Loss

Test Result: Not Applicable.

Remark: Not required by standard.

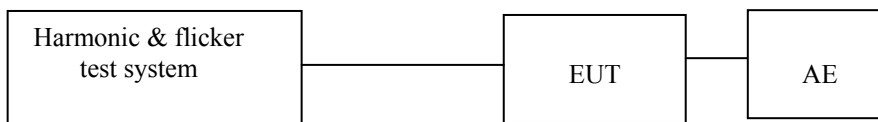
5 Harmonics of current

Test Result: Pass

5.1 Used Test Equipment

Equipment No.	Equipment	Model	Manufacturer
EM001-02	Harmonic & Flicker Test System	5001IX-CTS-400-413	California Instrument

5.2 Block Diagram of Test Setup



5.3 Test Setup and Procedure

Harmonics of the fundamental current were measured up to 40 order harmonics using a digital power meter with an analogue output and frequency analyzer which was integrated in the harmonic & flicker test system. The measurements were carried out under steady conditions.

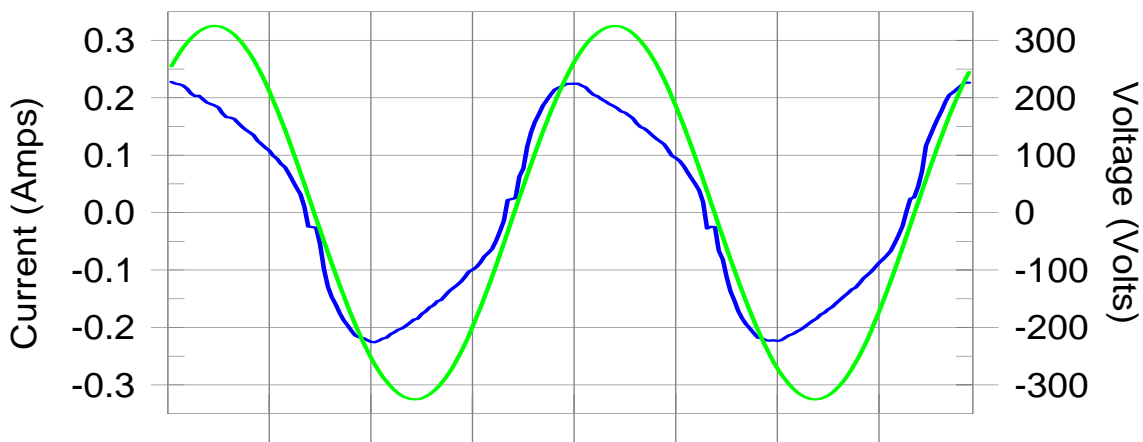
5.4 Test Data

Harmonics – Class-C per Ed. 3.2 (2009)(Run time) incl. inter-harmonics

Model: EIP030C0350LX

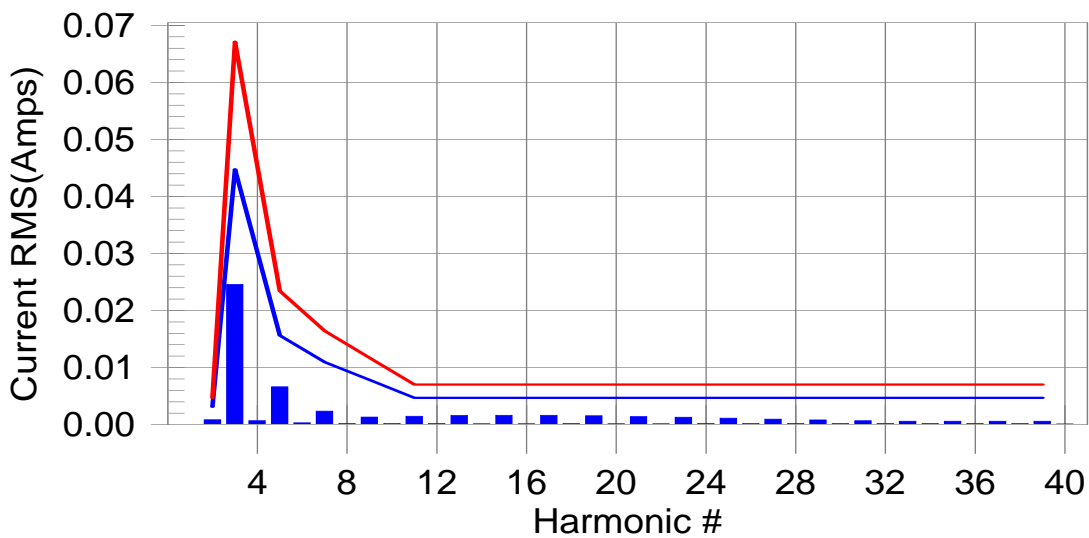
Test Result: Pass Source qualification: Normal

Current & voltage waveforms



Harmonics and Class C limit line

European Limits



Test result: Pass Worst harmonics H3-54.91% of 100% limit, H3-38.36% of 150% limit.



Current Test Result Summary (Run time)

Test Result: Pass Source qualification: Normal

THC(A): 0.03 I-THD(%): 16.62 POHC(A): 0.000 POHC Limit(A): 0.015

Highest parameter values during test:

V_RMS (Volts):	230.10	Frequency(Hz):	50.00
I_Peak (Amps):	0.231	I_RMS (Amps):	0.159
I_Fund (Amps):	0.156	Crest Factor:	1.458
Power (Watts):	34.8	Power Factor:	0.956

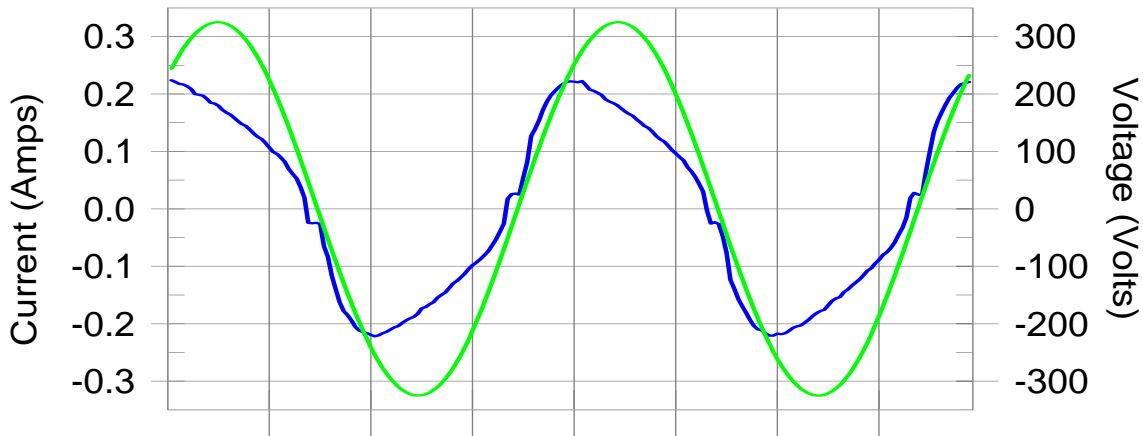
Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001	0.003	0.0	0.001	0.005	0.00	Pass
3	0.025	0.045	54.9	0.026	0.067	38.36	Pass
4	0.001						
5	0.007	0.016	42.4	0.008	0.023	34.35	Pass
6	0.000						
7	0.002	0.011	0.0	0.003	0.016	0.00	Pass
8	0.000						
9	0.001	0.008	0.0	0.001	0.012	0.00	Pass
10	0.000						
11	0.001	0.005	0.0	0.002	0.007	0.00	Pass
12	0.000						
13	0.002	0.005	0.0	0.002	0.007	0.00	Pass
14	0.000						
15	0.002	0.005	0.0	0.002	0.007	0.00	Pass
16	0.000						
17	0.002	0.005	0.0	0.002	0.007	0.00	Pass
18	0.000						
19	0.002	0.005	0.0	0.002	0.007	0.00	Pass
20	0.000						
21	0.001	0.005	0.0	0.001	0.007	0.00	Pass
22	0.000						
23	0.001	0.005	0.0	0.001	0.007	0.00	Pass
24	0.000						
25	0.001	0.005	0.0	0.001	0.007	0.00	Pass
26	0.000						
27	0.001	0.005	0.0	0.001	0.007	0.00	Pass
28	0.000						
29	0.001	0.005	0.0	0.001	0.007	0.00	Pass
30	0.000						
31	0.001	0.005	0.0	0.001	0.007	0.00	Pass
32	0.000						
33	0.001	0.005	0.0	0.001	0.007	0.00	Pass
34	0.000						
35	0.001	0.005	0.0	0.001	0.007	0.00	Pass
36	0.000						
37	0.001	0.005	0.0	0.001	0.007	0.00	Pass
38	0.000						
39	0.001	0.005	0.0	0.001	0.007	0.00	Pass
40	0.000						

Harmonics – Class-C per Ed. 3.2 (2009)(Run time) incl. inter-harmonics

Model: EIP030C0700LX

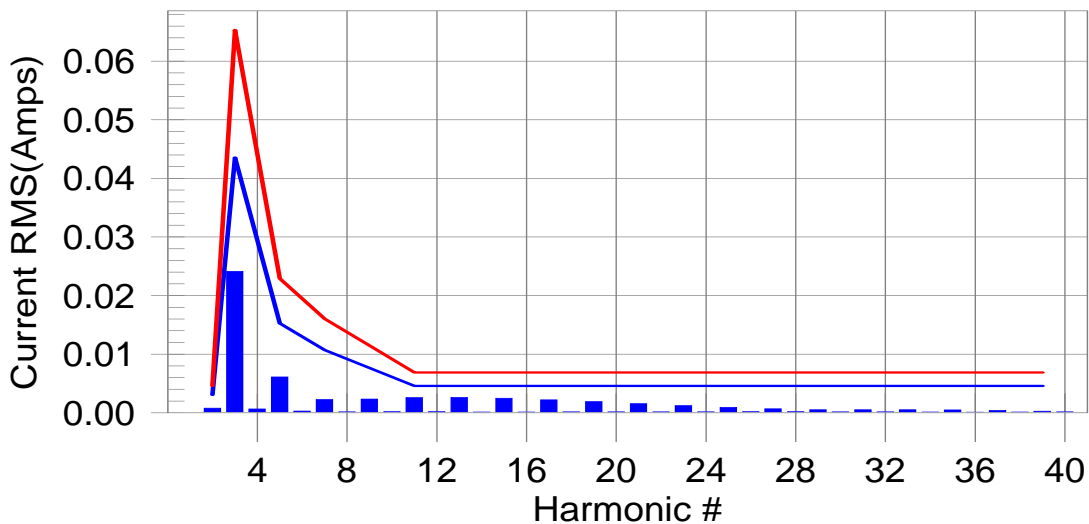
Test Result: Pass Source qualification: Normal

Current & voltage waveforms



Harmonics and Class C limit line

European Limits



Test result: Pass Worst harmonics H3-55.40% of 100% limit, H3-38.55% of 150% limit.



Current Test Result Summary (Run time)

Test Result: Pass Source qualification: Normal

THC(A): 0.02 I-THD(%): 16.19 POHC(A): 0.000 POHC Limit(A): 0.014

Highest parameter values during test:

V_RMS (Volts):	230.10	Frequency(Hz):	50.00
I_Peak (Amps):	0.227	I_RMS (Amps):	0.155
I_Fund (Amps):	0.153	Crest Factor:	1.474
Power (Watts):	33.8	Power Factor:	0.953

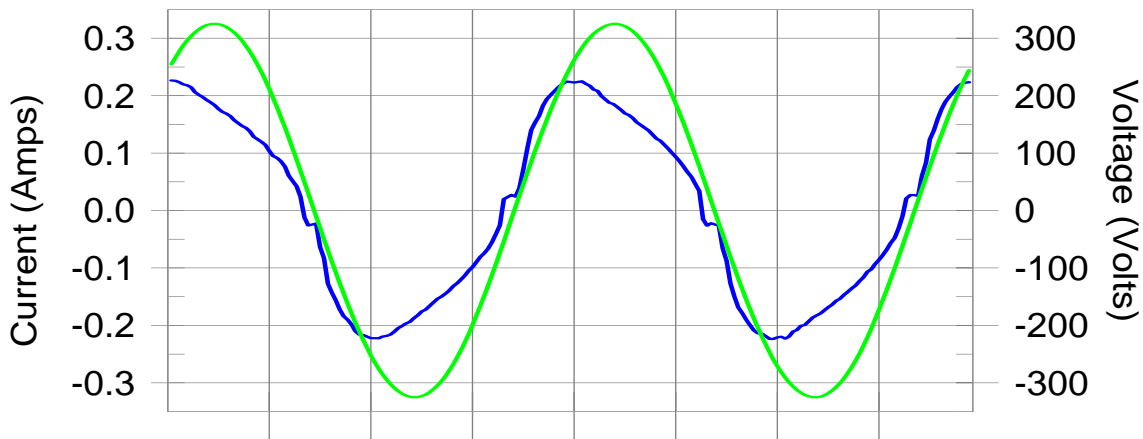
Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001	0.003	0.0	0.001	0.005	0.00	Pass
3	0.024	0.044	55.4	0.025	0.065	38.55	Pass
4	0.001						
5	0.006	0.015	40.1	0.007	0.023	32.49	Pass
6	0.000						
7	0.002	0.011	0.0	0.003	0.016	0.00	Pass
8	0.000						
9	0.002	0.008	0.0	0.003	0.011	0.00	Pass
10	0.000						
11	0.003	0.005	0.0	0.003	0.007	0.00	Pass
12	0.000						
13	0.003	0.005	0.0	0.003	0.007	0.00	Pass
14	0.000						
15	0.002	0.005	0.0	0.003	0.007	0.00	Pass
16	0.000						
17	0.002	0.005	0.0	0.002	0.007	0.00	Pass
18	0.000						
19	0.002	0.005	0.0	0.002	0.007	0.00	Pass
20	0.000						
21	0.002	0.005	0.0	0.002	0.007	0.00	Pass
22	0.000						
23	0.001	0.005	0.0	0.001	0.007	0.00	Pass
24	0.000						
25	0.001	0.005	0.0	0.001	0.007	0.00	Pass
26	0.000						
27	0.001	0.005	0.0	0.001	0.007	0.00	Pass
28	0.000						
29	0.001	0.005	0.0	0.001	0.007	0.00	Pass
30	0.000						
31	0.001	0.005	0.0	0.001	0.007	0.00	Pass
32	0.000						
33	0.000	0.005	0.0	0.001	0.007	0.00	Pass
34	0.000						
35	0.000	0.005	0.0	0.000	0.007	0.00	Pass
36	0.000						
37	0.000	0.005	0.0	0.000	0.007	0.00	Pass
38	0.000						
39	0.000	0.005	0.0	0.000	0.007	0.00	Pass
40	0.000						

Harmonics – Class-C per Ed. 3.2 (2009)(Run time) incl. inter-harmonics

Model: EIP030C1200LX

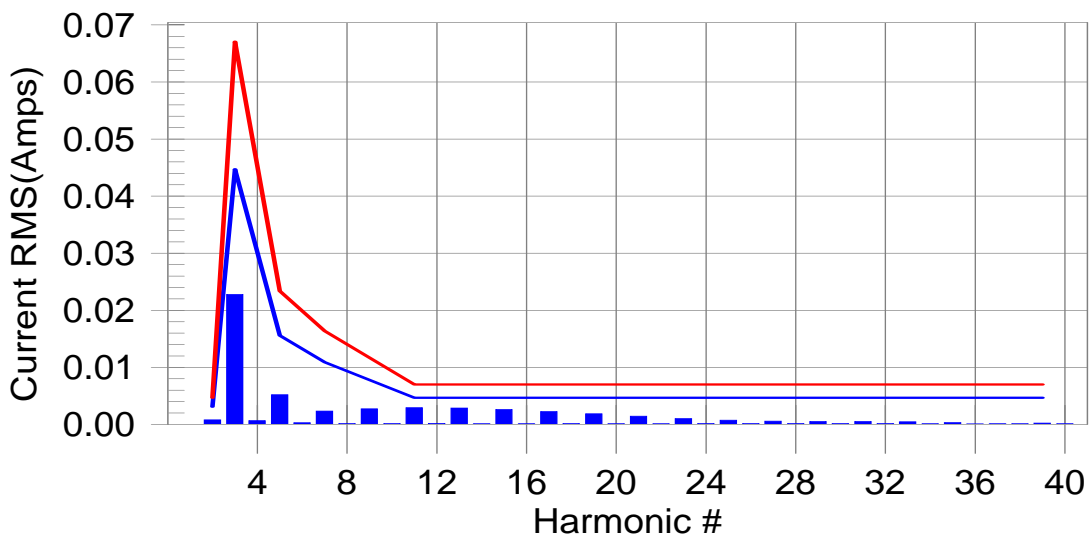
Test Result: Pass Source qualification: Normal

Current & voltage waveforms



Harmonics and Class C limit line

European Limits



Test result: Pass Worst harmonics H3-50.98% of 100% limit, H3-36.37% of 150% limit.



Current Test Result Summary (Run time)

Test Result: Pass Source qualification: Normal

THC(A): 0.02 I-THD(%): 14.93 POHC(A): 0.000 POHC Limit(A): 0.015

Highest parameter values during test:

V_RMS (Volts):	230.10	Frequency(Hz):	50.00
I_Peak (Amps):	0.231	I_RMS (Amps):	0.158
I_Fund (Amps):	0.156	Crest Factor:	1.468
Power (Watts):	34.6	Power Factor:	0.958

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001	0.003	0.0	0.001	0.005	0.00	Pass
3	0.023	0.045	51.0	0.024	0.066	36.37	Pass
4	0.001						
5	0.005	0.016	33.8	0.007	0.023	28.79	Pass
6	0.000						
7	0.002	0.011	0.0	0.003	0.016	0.00	Pass
8	0.000						
9	0.003	0.008	0.0	0.003	0.012	0.00	Pass
10	0.000						
11	0.003	0.005	0.0	0.003	0.007	0.00	Pass
12	0.000						
13	0.003	0.005	0.0	0.003	0.007	0.00	Pass
14	0.000						
15	0.003	0.005	0.0	0.003	0.007	0.00	Pass
16	0.000						
17	0.002	0.005	0.0	0.002	0.007	0.00	Pass
18	0.000						
19	0.002	0.005	0.0	0.002	0.007	0.00	Pass
20	0.000						
21	0.001	0.005	0.0	0.001	0.007	0.00	Pass
22	0.000						
23	0.001	0.005	0.0	0.001	0.007	0.00	Pass
24	0.000						
25	0.001	0.005	0.0	0.001	0.007	0.00	Pass
26	0.000						
27	0.001	0.005	0.0	0.001	0.007	0.00	Pass
28	0.000						
29	0.001	0.005	0.0	0.001	0.007	0.00	Pass
30	0.000						
31	0.001	0.005	0.0	0.001	0.007	0.00	Pass
32	0.000						
33	0.000	0.005	0.0	0.000	0.007	0.00	Pass
34	0.000						
35	0.000	0.005	0.0	0.000	0.007	0.00	Pass
36	0.000						
37	0.000	0.005	0.0	0.000	0.007	0.00	Pass
38	0.000						
39	0.000	0.005	0.0	0.000	0.007	0.00	Pass
40	0.000						

5.5 Measurement Uncertainty

The measurement uncertainty for harmonic test is under consideration according to CISPR 16-4-2:2003.

6 Flicker

Test Result: Pass

6.1 Used Test Equipment

Equipment No.	Equipment	Model	Manufacturer
EM001-02	Harmonic & Flicker Test System	5001IX-CTS-400-413	California Instrument

6.2 Block Diagram of Test Setup



6.3 Test Setup and Procedure

6.3.1 Definition

- Flicker: impression of unsteadiness of visual sensation induced by a lighting stimulus whose luminance or spectral distribution fluctuates with time.
- Pst: Short-term flicker indicator The flicker severity evaluated over a short period (in minutes); Pst=1 is the conventional threshold of irritability
- Plt: long-term flicker indicator; the flicker severity evaluated over a long period (a few hours). Using successive Pst value.
- dc: the relative steady-state voltage change
- dmax: the maximum relative voltage change
- d(t): the value during a voltage change

6.3.2 Test condition

The EUT was set to produce the most unfavourable sequence of voltage changes.

Remark: This apparatus is unlikely to produce significant voltage fluctuations and flicker by examination of the circuit diagram and specification of it. Therefore, it is deemed to fulfill the relevant standard without testing according to clause 6.1 of EN 61000-3-3.

6.4 Measurement Uncertainty

Measurement uncertainty for voltage fluctuation and flicker is under consideration according to CISPR 16-4-2:2003.

7 EMS TEST

Performance Criteria:

- Criterion A: During the test no change of the luminous intensity shall be observed and the regulating control, if any, shall operate during the test as intended.
- Criterion B: During the test the luminous intensity may change to any value. After the test the luminous intensity shall be restored to its initial value within 1 min.
 Regulating controls need not function during the test, but after the test the mode of the control shall be the same as before the test provided that during the test no mode changing commands were given.
- Criterion C: During and after the test any change of the luminous intensity is allowed and the lamp(s) may be extinguished. After the test, within 30 min, all functions shall return to normal if necessary by temporary interruption of the mains supply and /or operating the regulating control.
 Additional requirement for lighting equipment incorporation a starting device:
 After the test the lighting equipment is switched off. After half an hour it is witched on again. The lighting equipment shall start and operate as intended.

Measurement Uncertainty

According to CISPR 16-4-2:2003, measurement uncertainty to immunity test is under consideration.

Note: "N/A" means Not Applicable in below text.

7.1 EN 61000-4-2(Pursuant to EN 61547) Electrostatic Discharge Immunity

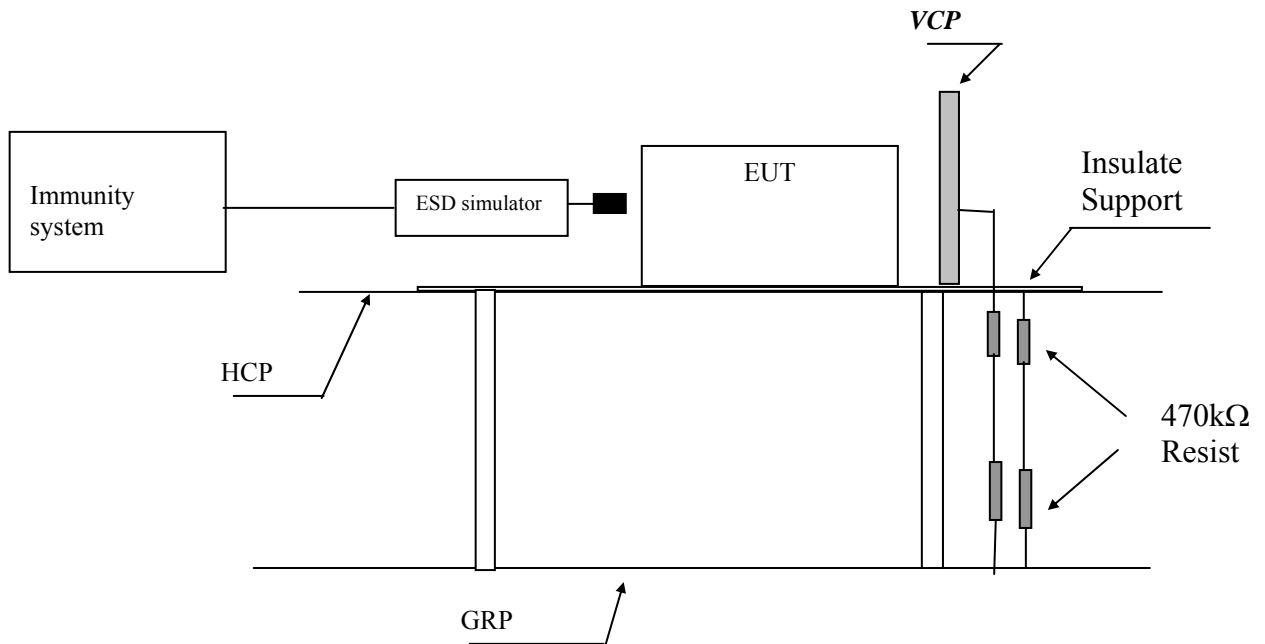
Performance criterion: B

Test Result: Pass

7.1.1 Used Test Equipment

Equip. No.	Equipment	Model	Manufacturer
EM077-02	ESD Simulator	NSG435	SCHAFFNER

7.1.2 Block Diagram of Test Setup



Note: HCP means Horizontal Coupling Plane,
 VCP means Vertical Coupling Plane
 GRP means Ground Reference Plane

7.1.3 Test Setup and Procedure

The EUT was put on a $(0,8 \pm 0,08)$ m high wooden table/0.1m high for floor standing equipment standing on the ground reference plane (GRP) 3m by 2m in size, made by iron 1.0 mm thick. A horizontal coupling plane (HCP) $(1,6 \pm 0,02)$ m by $(0,8 \pm 0,02)$ m in size was placed on the table, and the EUT with its cables were isolated from the HCP by an insulating support with $(0,5 \pm 0,05)$ mm thick. The VCP 0.5m by 0.5m in size & HCP were constructed from the same material type & thickness as that of the GRP, and connected to the GRP via a 470kΩ resistor at each end.

For floor standing equipment, The EUT shall be isolated from the ground reference plane by an insulating support of 0,05 m to 0,15 m thick. The EUT cables shall be isolated from the ground reference plane by an insulating support of $(0,5 \pm 0,05)$ mm. This cable isolation shall extend beyond the edge of the EUT isolation.

The distance between EUT and any of the other metallic surface excepted the GRP, HCP & VCP was greater than 0.8m.

The EUT was arranged and connected according to its functional requirements.

Direct static electricity discharges was applied only to those points and surface which are accessible to personnel during normal usage, terminals are excluded.

On each preselected points 10 times of each polarity single discharge were applied .

The ESD generator was held perpendicular to the surface to which the discharge is applied.

The discharge return cable of the generator was kept at a distance of 0.2m whilst the discharge is being applied. During the contact discharges, the tip of the discharge electrode was touch the EUT before the discharge switch is operated. During the air discharges, the round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT.

Indirect discharge was conducted to objects placed near the EUT, simulated by applying the discharges of the ESD generator to a coupling plane, in the contact discharge mode.

After each discharge, the ESD generator was removed from the EUT, the generator is then retriggered for a new single discharge. For ungrounded product, a grounded carbon fibre brush with bleeder resistors ($2 \times 470 \text{ k}\Omega$) in the grounding cable was used after each discharge to remove remnant electrostatic voltage.

10 times of each polarity single discharge were applied to HCP and VCP. The detail selected points are listed in the following table.

7.1.4 Test Result

Direct Application of ESD

Direct Contact Discharge

Applied Voltage (kV)	No. of Discharge for each point	Result (Pursuant to EN 61547)	Discharged Points
4	20	Pass	Accessible metal parts of the EUT Conductive substrate with coating which is not declared to be insulating

Direct Air Discharge

Applied Voltage (kV)	No. of Discharge for each point	Result (Pursuant to EN 61547)	Discharged Points
2, 4, 8	20	Pass	All accessible points where contact discharge cannot be applied such as Displays, Indicators light, Keyboard, Button, Switch, Knob, Air gap, Slots, Hole and so on

Indirect Application of ESD

Horizontal Coupling Plane under the EUT

Applied Voltage (kV)	No. of Discharge for each point	Result (pursuant to EN 61547)	Discharged Point
4	20	Pass	At the front edge of each HCP opposite the centre point of each unit of the EUT

Vertical Coupling Plane beside the EUT

Applied Voltage (kV)	No. of Discharge for each point	Result (pursuant to EN 61547 criterion B)	Discharged Point
4	20	Pass	The centre of the vertical edge of the coupling plane

7.2 EN 61000-4-6(Pursuant to EN 61547) Injected Current (0.15 MHz to 80 MHz)

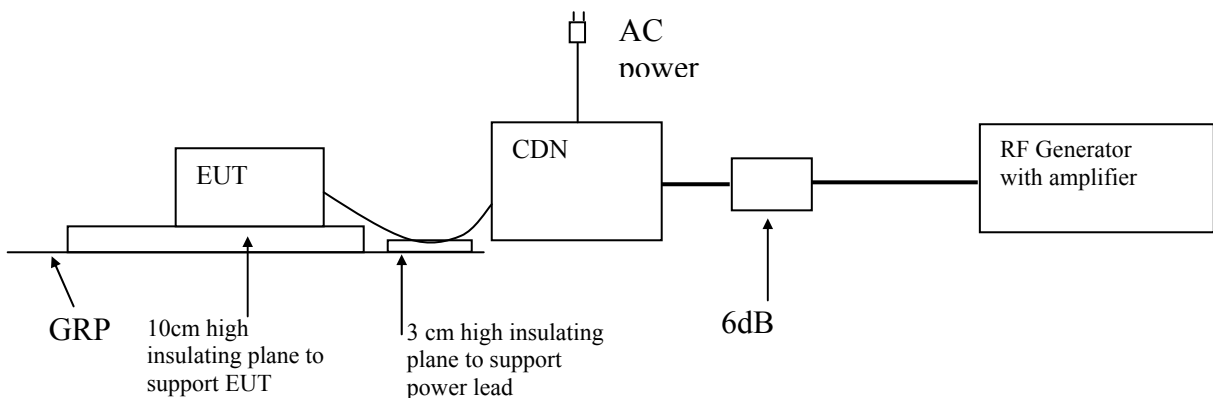
Performance criterion: A

Test Result: Pass

7.2.1 Used Test Equipment

Equip. No.	Equipment	Model	Manufacturer
EM003-01	Conducted Disturbance Generator	CDG_1020	Dr.Hubert GmbH

7.2.2 Block Diagram of Test Setup



7.2.3 Test Setup and Procedure

The EUT was placed on an insulating support of 0.1m height above a ground reference Plane, arranged and connected to satisfy its functional requirement.

All relevant cables were provided with the appropriate coupling and decoupling devices at a distance between 0.1m and 0.3m from the projected geometry of the EUT on an insulating support of 0.03m height above the ground reference plane.

Test voltage was verified before each testing though power meter combined in the RF generator with AMP.

Dwell time was set to 3s and step was set as 1% to keep sufficient response time for EUT.

The frequency from 0.15MHz to 80MHz was checked.

7.2.4 Test Result

Port:	Frequency (MHz)	Level (Pursuant to EN 61547)	Result
A.C. Power Lines	0.15 to 80	3V (r.m.s.)	Pass
D.C. Power Lines	0.15 to 80	3V (r.m.s.)	N/A
Signal Lines	0.15 to 80	3V (r.m.s.)	N/A
Control Lines	0.15 to 80	3V (r.m.s.)	N/A

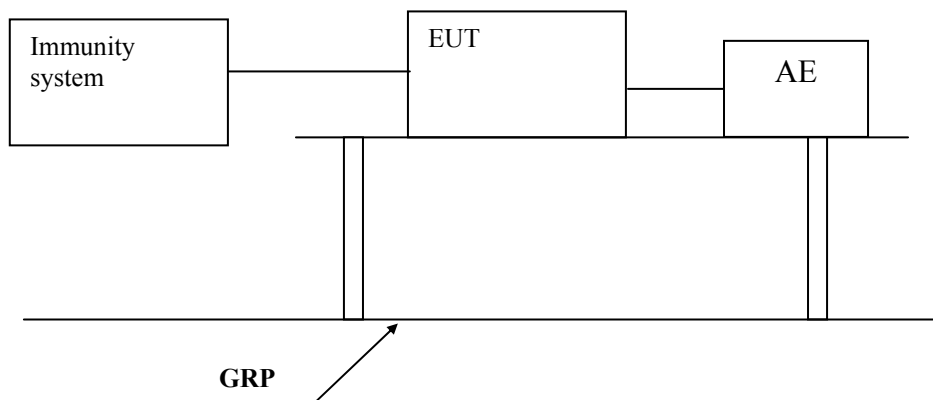
7.3 EN 61000-4-4(Pursuant to EN 61547) Electrical Fast Transient/Burst

Performance criterion: B
Test Result: Pass

7.3.1 Used Test Equipment

Equipment No.	Equipment	Model	Manufacturer
EM005-07	EMS test system	Ecompact 4	HAEFELY

7.3.2 Block Diagram of Test Setup



7.3.3 Test Setup and Procedure

The EUT was placed on a 0.1m high wooden table, standing on the ground reference plane 3m by 2m in size, made by steel 1mm thick.

The distance between the EUT and any other of the metallic surface except the GRP is greater than 0.5m.

The mains lead excess than 0.5m is folded to avoid a flat coil and situated at a distance of 0.1m above the ground reference plane to insure the distance between the coupling device and the EUT were 0.5m.

The EUT was arranged and connected to satisfy its functional requirement and supplied by the coupling-decoupling network.

7.3.4 Test Result

Level (Pursuant to EN 61547)	Polarity	Input and Output A.C. Power Ports	D.C. Power Ports, Signal and Control Lines
0.5kV	+	N/A	N/A
0.5kV	-	N/A	N/A
1kV	+	Pass	N/A
1kV	-	Pass	N/A

7.4 EN 61000-4-5(Pursuant to EN 61547) Surge Immunity

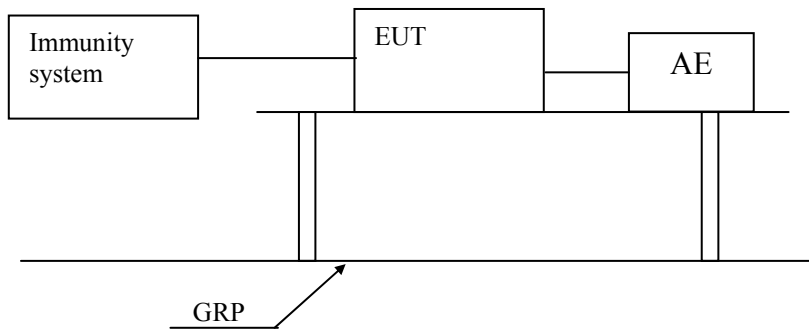
Performance criterion: C
 B (luminaire for emergency lighting)

Test Result: Pass

7.4.1 Used Test Equipment

Equipment No.	Equipment	Model	Manufacturer
EM005-09	Surge/DIP Generator	NSG3040	TESEQ

7.4.2 Block Diagram of Test Setup



7.4.3 Test Setup and Procedure

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network.

Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines and to provide sufficient decoupling impedance to the surge wave so that the specified wave may be developed on the lines under test.

The EUT was arranged and connected according to its functional requirements.

The EUT was placed on a 0.1m high wooden support above the GRP), supplied by the coupling-decoupling network, and arranged and connected to satisfy its functional requirement. The power cord between the EUT and the coupling/decoupling network was less than 2 meters.

Five positive and five negative pulses shall be applied at the peak value and zero crossing points of the a.c. voltage wave.

7.4.4 Test Result

I. For Self-ballasted lamps and semi-luminaires and independent auxiliaries with input power less or equal to 25 W:

Level (Pursuant to EN 61547)	Result
Between Phase And Phase: 0.5 kV	N/A
Between Phase And Neutral: 0.5 kV	N/A
Between Phase And Earth: 0.5 kV, 1.0 kV	N/A
Between Neutral And Earth: 0.5 kV, 1.0 kV	N/A

II. For luminaires and independent auxiliaries with input power greater than 25 W:

Level (Pursuant to EN 61547)	Result
Between Phase And Phase: 0.5 kV, 1.0 kV	N/A
Between Phase And Neutral: 0.5 kV, 1.0 kV	Pass
Between Phase And Earth: 0.5 kV, 1.0 kV, 2.0 kV	N/A
Between Neutral And Earth: 0.5 kV, 1.0 kV, 2.0 kV	N/A

7.5 EN 61000-4-11(Pursuant to EN 61547) Voltage Dips and Interruptions

Performance criterion:

for table 11 of EN 61547 ----- C

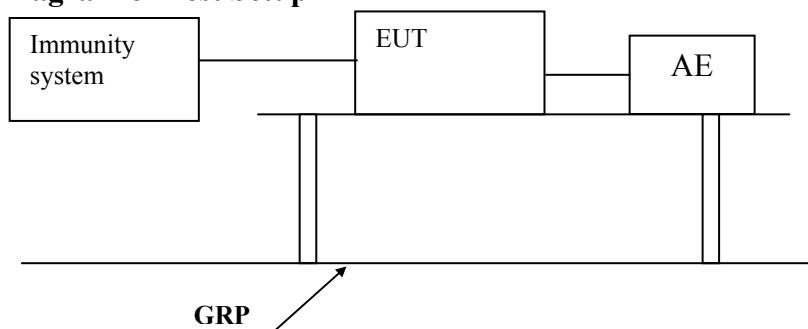
for table 12 of EN 61547----- B

Test Result: Pass

7.5.1 Used Test Equipment

Equipment No.	Equipment	Model	Manufacturer
EM005-07	EMS test system	Ecompact 4	HAEFELY

7.5.2 Block Diagram of Test Setup



7.5.3 Test Setup and Procedure

The EUT was placed on an insulating support of 0.8m height, standing on a ground reference plane, and arranged and connected to satisfy its functional requirement

The test was performed with the EUT connected to the test generator with the shortest power supply cable as specified by the EUT manufacturer.

The EUT was tested for each selected combination of test level and duration with a sequence of three dips/interruptions with intervals of 10 s minimum. Each representative mode of operation was tested.

EUT is tested for voltage reduction of 0% U_T , 0.5 period, 70% U_T , 10 periods, both the positive and negative polarity test was conducted.

Changes to the voltage level shall occur at a zero crossing point in the a.c. voltage waveform.

7.5.4 Test Result

I. According to table 11 of EN 61547

Test condition (Pursuant to EN 61547)		Result
Test Level in % U_T	Duration (in period of the rated frequency)	
70	10	Pass

II. According to table 12 of EN 61547

Test condition (Pursuant to EN 61547)		Result
Test Level in % U_T	Duration (in period of the rated frequency)	
0	0.5	Pass

Remark: U_T is the rated voltage for the equipment.

7.6 EN 61000-4-3(Pursuant to EN 61547) Radiated Electromagnetic Field Immunity

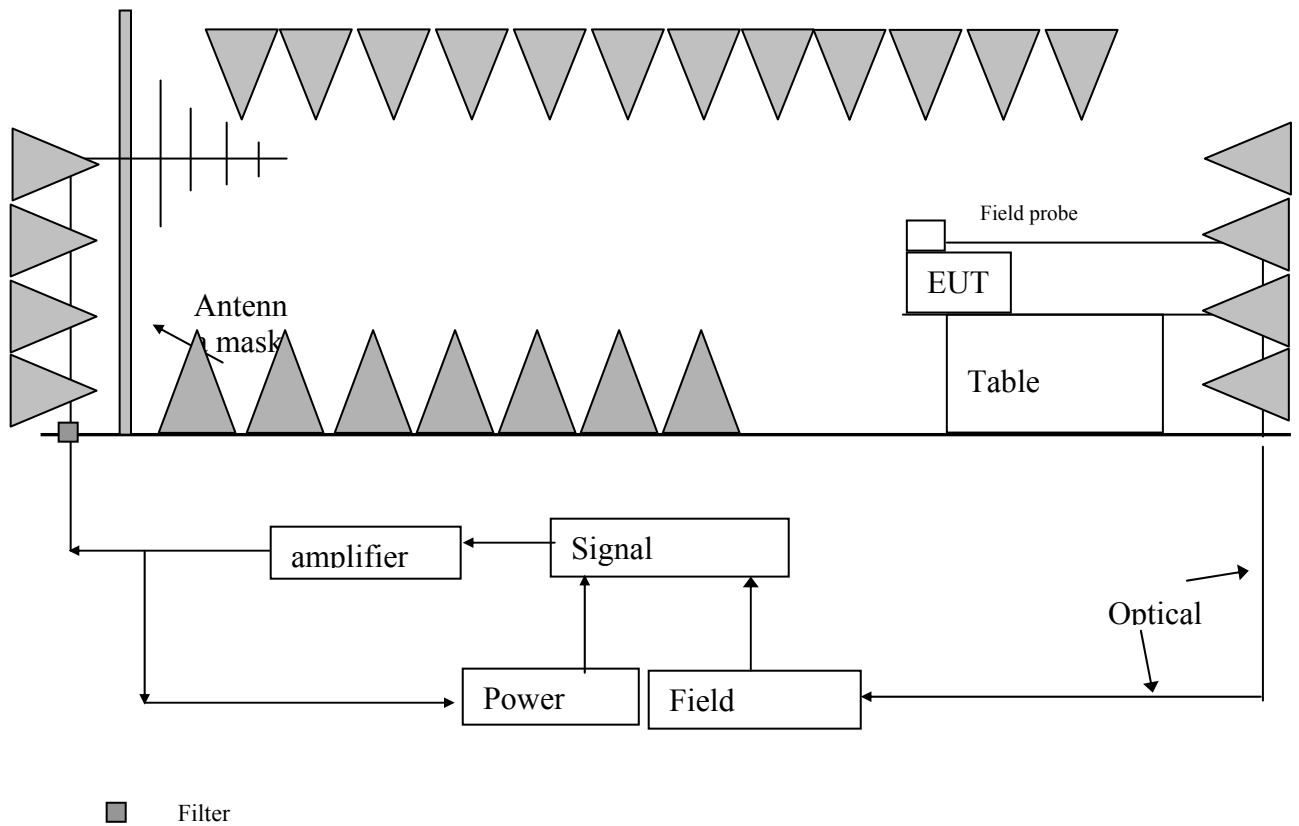
Performance criterion: A

Test Result: Pass

7.6.1 Used Test Equipment

Equipment No.	Equipment	Model	Manufacturer
103002	Signal generator	SML03	Rohde & Schwarz
10543	Power Meter	4232A	BOOTON
0611-768	Power Amplifier	AP32DT214	PRAnA
0611-767	Power Amplifier	AP32SV150A	PRAnA
75971	Double Log.-Per. Antenna	STLP9128E	SCHWARZBECK
BBHA9120E318/ 0899	Horn Antenna	BBHA 9120 E	SCHWARZBECK

7.6.2 Block Diagram of Test Setup



7.6.3 Test Setup and Procedure

The test was conducted in an fully anechoic chamber to maintain a uniform field of sufficient dimensions with respect to the EUT, and also in order to comply with various national and international laws prohibiting interference to radio communications.

The equipment is placed in the test facility on a non-conducting table 0.8m high (for floor standing EUT, is placed on a non-conducting support 0.1m height).

The EUT was placed on the uniform calibrated plane which is 3V/m EM field.

For all ports connected to EUT, manufacturer specified cable type and length was used, for those cables no specification, unshielded cable applied.

Wire is left exposed to the electromagnetic field for a distance of 1m from the EUT.

The EUT was arranged and connected according to its functional requirements

Before testing, the intensity of the established field strength have been checked by placing the field sensor at a calibration grid point, and with the field generating antenna and cables in the same positions as used for the calibration, the forward power needed to give the calibrated field strength was measured.

Spot checks was made at a number of calibration grid points over the frequency range 80MHz to 1000MHz, both polarizations was checked.

After calibration, the EUT is initially placed with one face coincident with the calibration plane.

The frequency range is swept from 80MHz to 1000MHz, with the signal 80% amplitude modulated with a 1 kHz sinewave, pausing to adjust the r.f. signal level.

The dwell time at each frequency was 3s so as that the EUT to be exercised and be able to respond.

The step size was 1% of the fundamental with linear interpolation between calibrated points. Test was performed with the generating antenna facing each of the four sides of the EUT.

7.6.4 Test Result

Frequency (MHz)	Exposed Side	Field Strength (V/m)	Result
80 to 1000	Front	3V/m (r.m.s.)	Pass
80 to 1000	Left	3V/m (r.m.s.)	Pass
80 to 1000	Rear	3V/m (r.m.s.)	Pass
80 to 1000	Right	3V/m (r.m.s.)	Pass

7.7 EN 61000-4-8(Pursuant to EN 61547) Power Frequency Magnetic Field Immunity

Performance criterion: A

Test Result: Not Applicable

Remark:

Equipment containing no Hall elements or magnetic field sensors is not susceptible to magnetic field. Hence, this equipment is deemed to fulfil the magnetic field test.

8 Appendix I - Photos of test setup

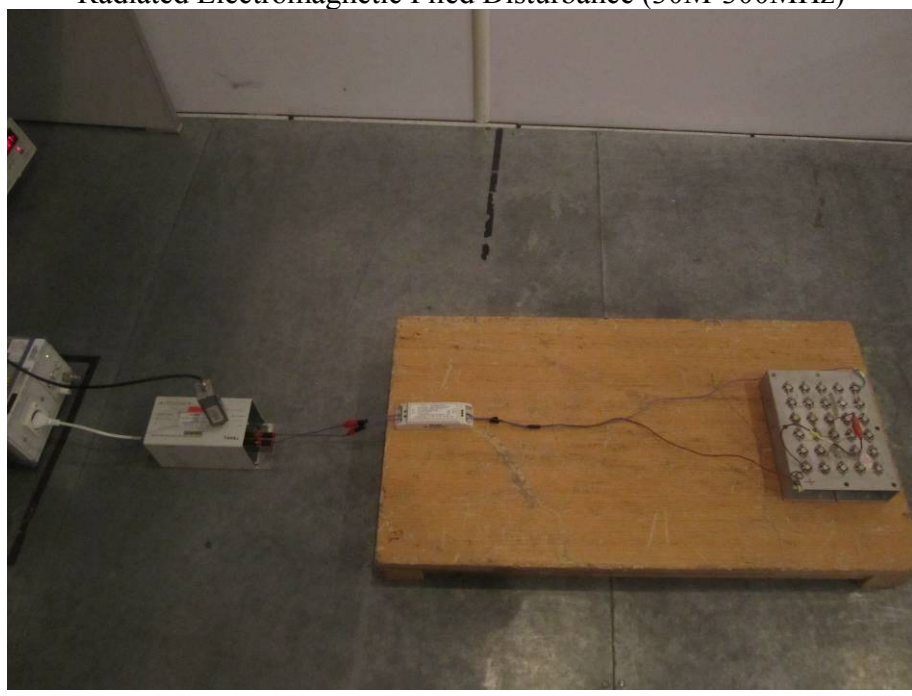
Conducted Emission



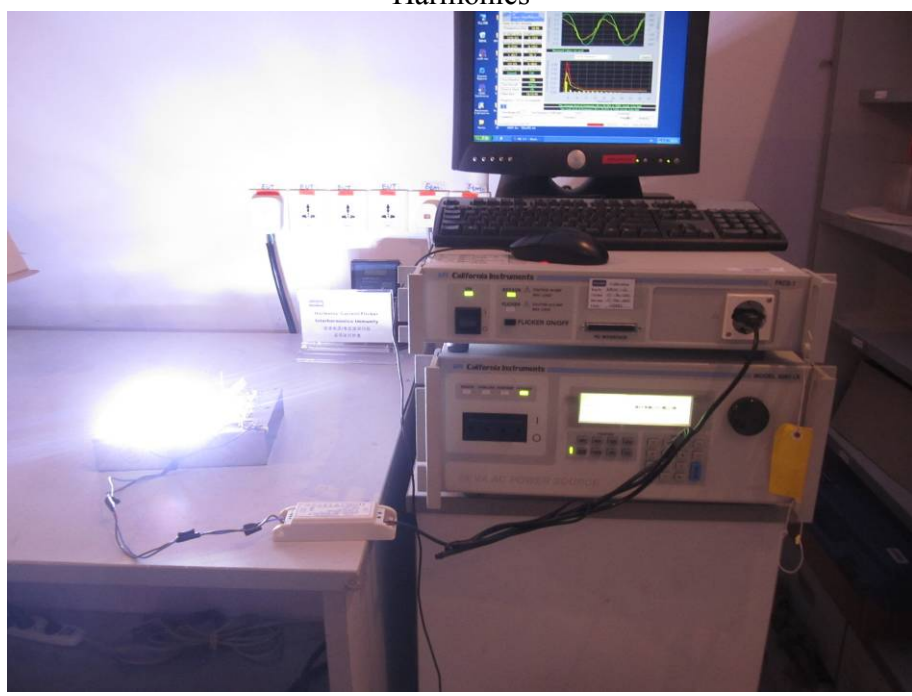
Radiated Electromagnetic Filed Disturbance (9k-30MHz)



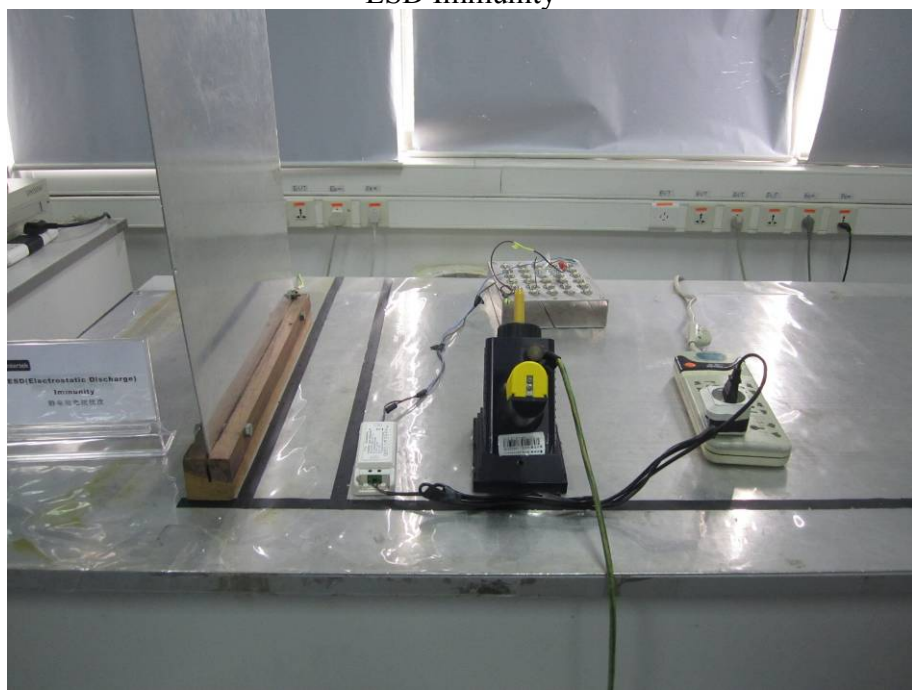
Radiated Electromagnetic Filed Disturbance (30M-300MHz)



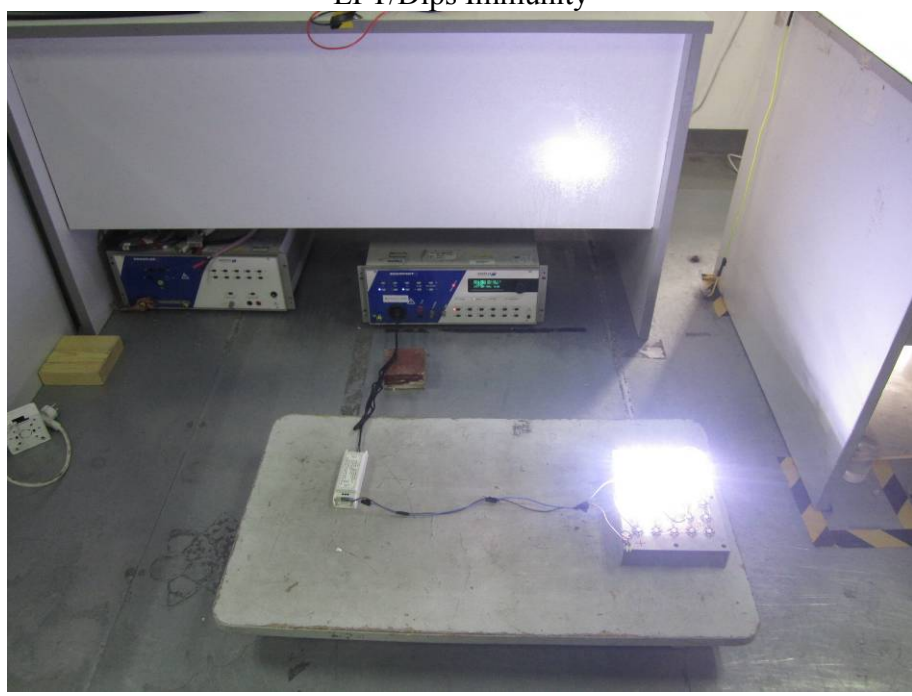
Harmonics



ESD Immunity



EFT/Dips Immunity



Surge Immunity



Conducted Immunity



Radiated field Immunity

